

# Epitaxial Graphene

## A new electronic material

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X. Wu, M. Sprinkle, M. Ruan, Y. Hu, G. Rutter, L. Miller,  
K. Kubista, J. Hass, N. Sharma,

**NIST**

J. Stroscio, and others (NIST)

**CEA**

P. Soukiassian

**Soleil**

A. Taleb-Ibrahimi A. Tejeda

**CNRS**

M. Potemski, G. Martinez, C. Faugeras

(other collaborators will be acknowledged later)

# The History of Graphene

Graphitic layers on transition metals, carbides known since the early '70s

## First identification of:

**“monolayer of graphite”**

**“single-crystal plane”**

**“two-dimensional graphite”**

SiC	Van Bommel, Surf. Sci. (1975)
LaB <sub>6</sub>	Oshima Appl Phys (1977)
Pt	Zi-Du Surface Science (1987)...
Ni	Rosei PRB(1983)
Ir	Kholin Surf Sci (1984)
Re	Gall Sov Phys Sol State (1985)
TaC	Aizawa PRL 1990
TiC	Nagashima, Surf Sci (1993)
Ru	Marchini (2007)
WC	TaC, HfC,...
SiC	Forbeaux (1998)
SiO <sub>2</sub>	Novoselov Nature (2004) <b>(Thin graphite)</b>
SiC	Berger J. Chem Phys (2004) <b>(Epitaxial graphiene)</b>
SiO <sub>2</sub>	Novoselov Nature (2005) <b>(Exfoliated graphene)</b>
SiO <sub>2</sub>	Zhang Nature (2005) <b>(Exfoliated graphene)</b>

**The breakthrough:  
Gateable graphenes  
Emphasis on transport**

Graphene was experimentally well-known as a 2D crystal!  
See, for example

**Thin Solid Films 266 ( 1995) 229-233**

**N.R. Gall, E.V. Rut'kov, A.Ya. Tontegode**

### **3.2. *Monolayer graphite***

**Graphite films of monolayer thickness form on the surface of many metals  
(Ir, Re, MO, Pt, Ni, Rh) ....**

**...Monolayer graphite films preserve their individuality as two-dimensional  
crystals on the surface of the metals [ 61]**

**...Valence saturation of monolayer graphite films leads to their catalytic  
passivity and to a weak bonding only by Van der Waals forces [9]. ...**

**...many atoms (Cs, K, Ba, C, Pt, Si, Au, etc.) [6,19] and even molecules (C<sub>60</sub>) [20] can  
intercalate into MGF, penetrating between the graphite layer and the metal surface  
[6,19,21].**



*So why did it take so long for  
graphene to catch on?*

*Almost*  
**NOBODY CARED!**

Epitaxial graphene is not an isolated single graphene sheet. However, it is easily made and it exhibits several graphene properties more clearly than exfoliated graphene!

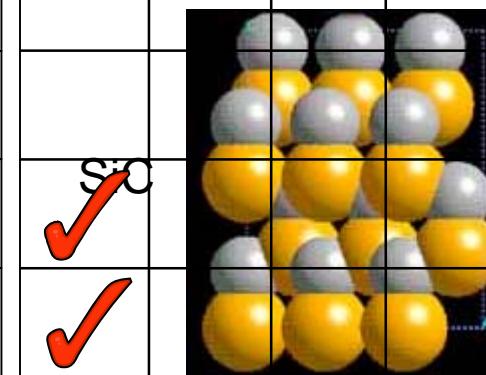
# Graphene Properties

<b>Scalability</b>
<b>Mobilities &gt;10<sup>5</sup>cm<sup>2</sup>/Vsec</b>
<b>Doping &lt; 10<sup>10</sup>/cm<sup>2</sup></b>
<b>Berry's phase of <math>\pi</math></b>
<b>Landau Level E <math>\propto \sqrt{B}</math></b>
<b>Weak anti-localization</b>
<b>Gapless Linear Dispersion</b>

*ITRS 2007 emerging material and research devices*

	UHV	Furnace	
graphene	Si-face	C-face	Si-face
Tape	Si-face	C-face	Si-face

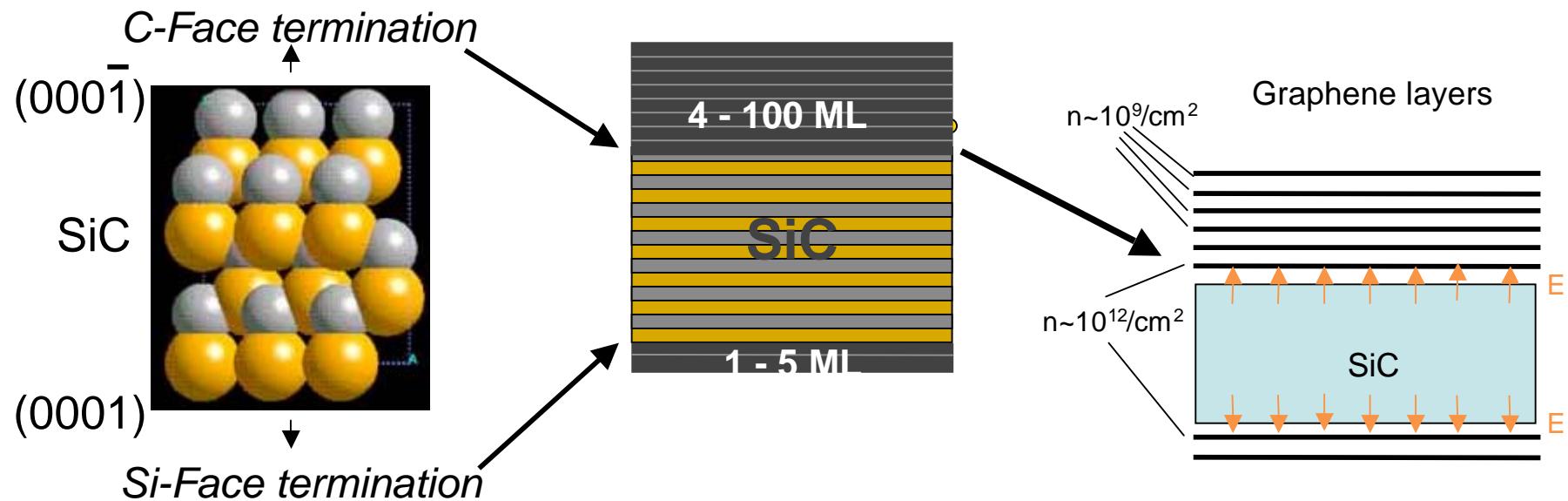
	✓	✓	✓	✓
	✓	✓	✓	✓
	✓	✓	✓	✓
	✓	✓	✓	✓
	?	?	✓	✓



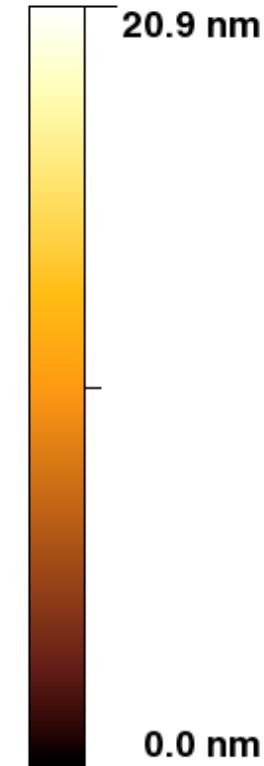
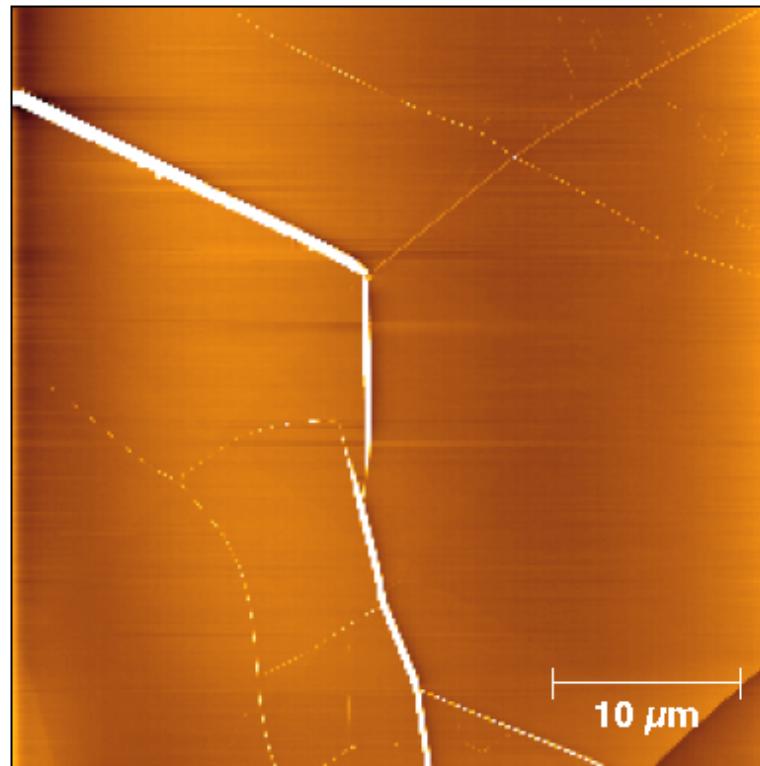
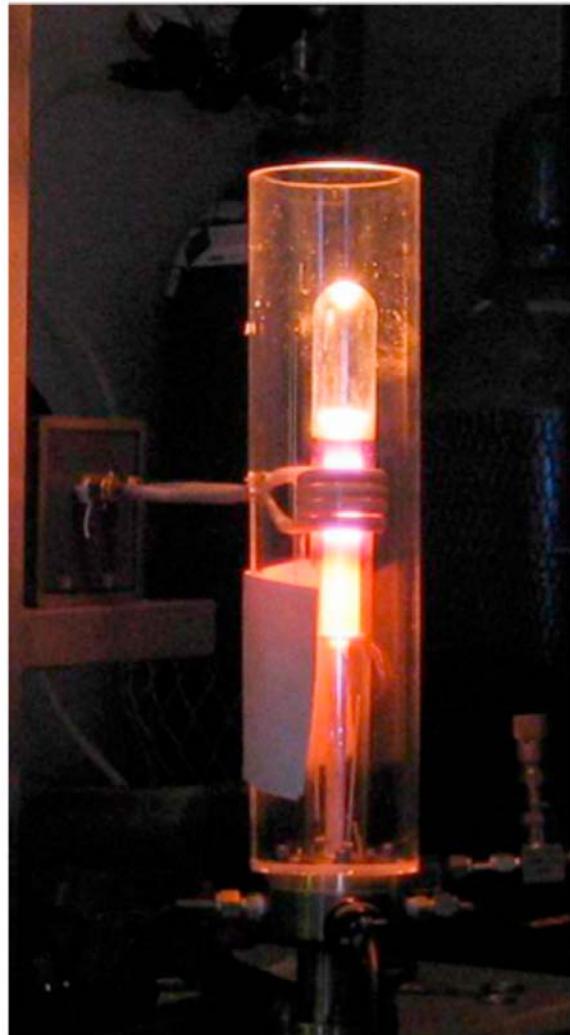
↑  
C-Face termination  
↓  
Si-Face termination

# **Production and Structure of Multilayered Epitaxial Graphene**

# Epitaxial Graphene on SiC



# AFM: C-face MEG

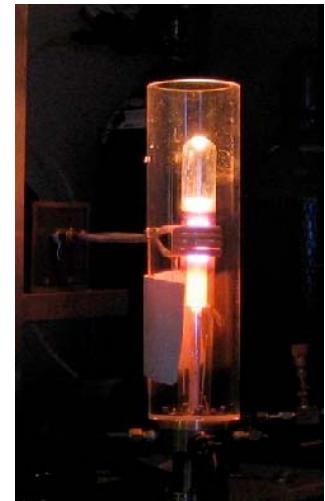
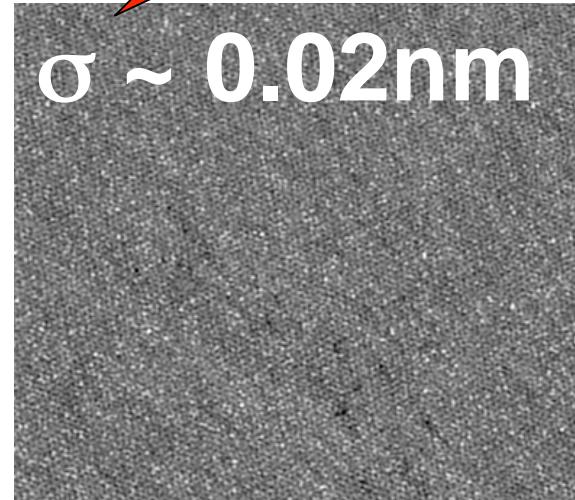
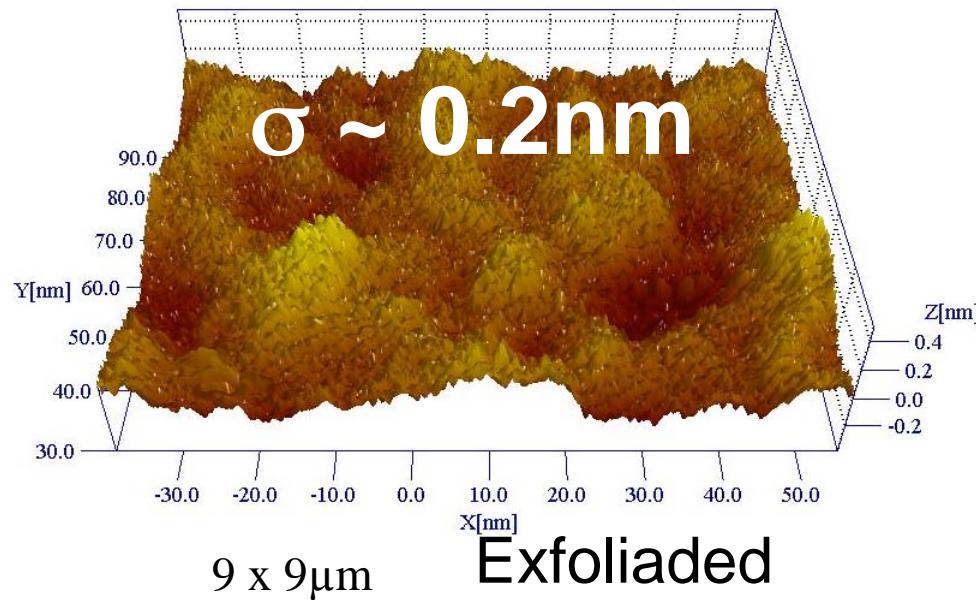
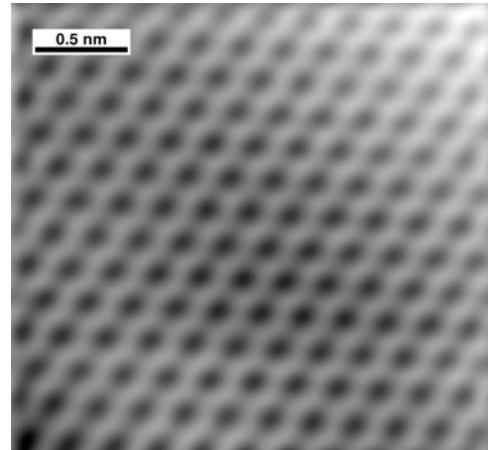
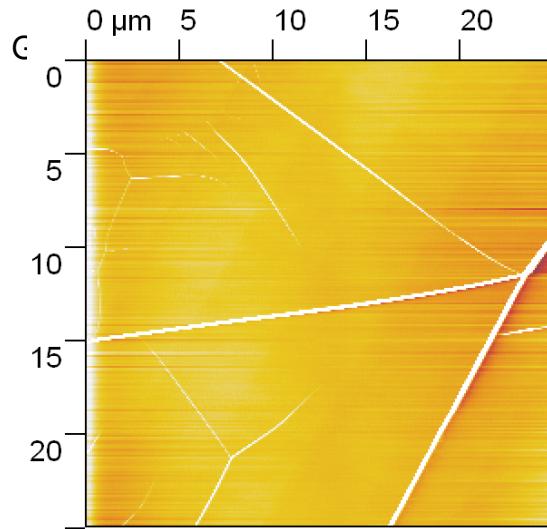


C-face, HV ( $\sim 10^{-5}$  Torr)  
RF induction furnace  
 $\sim 1450$  °C, 7 min.

See M. Ruan W26.011

EPITAXIAL  
GRAPHENE  
on SiC

# Graphene Growth



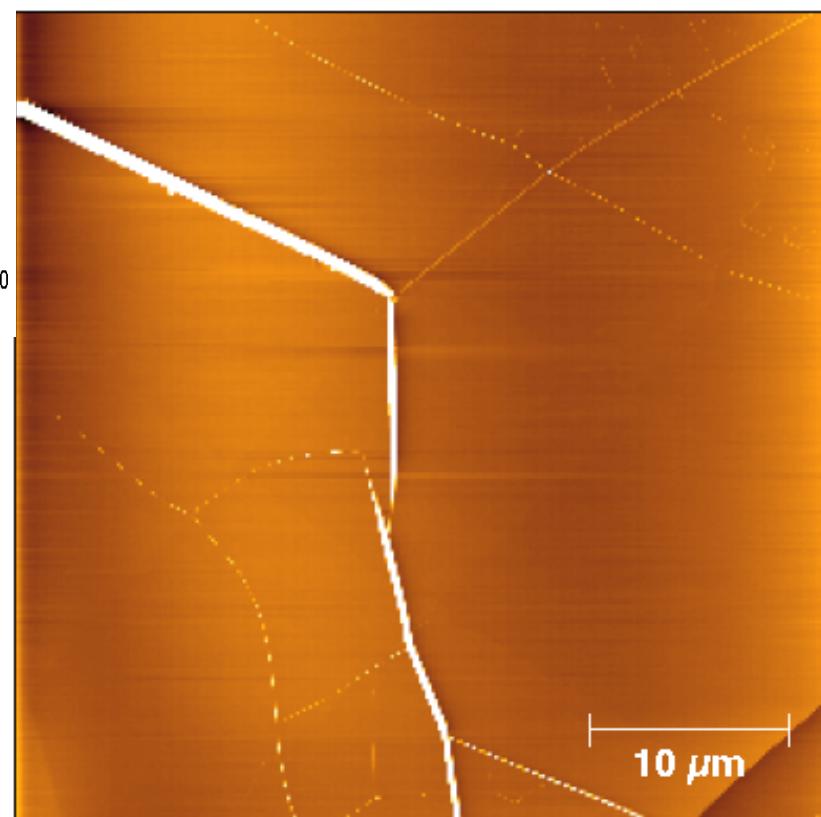
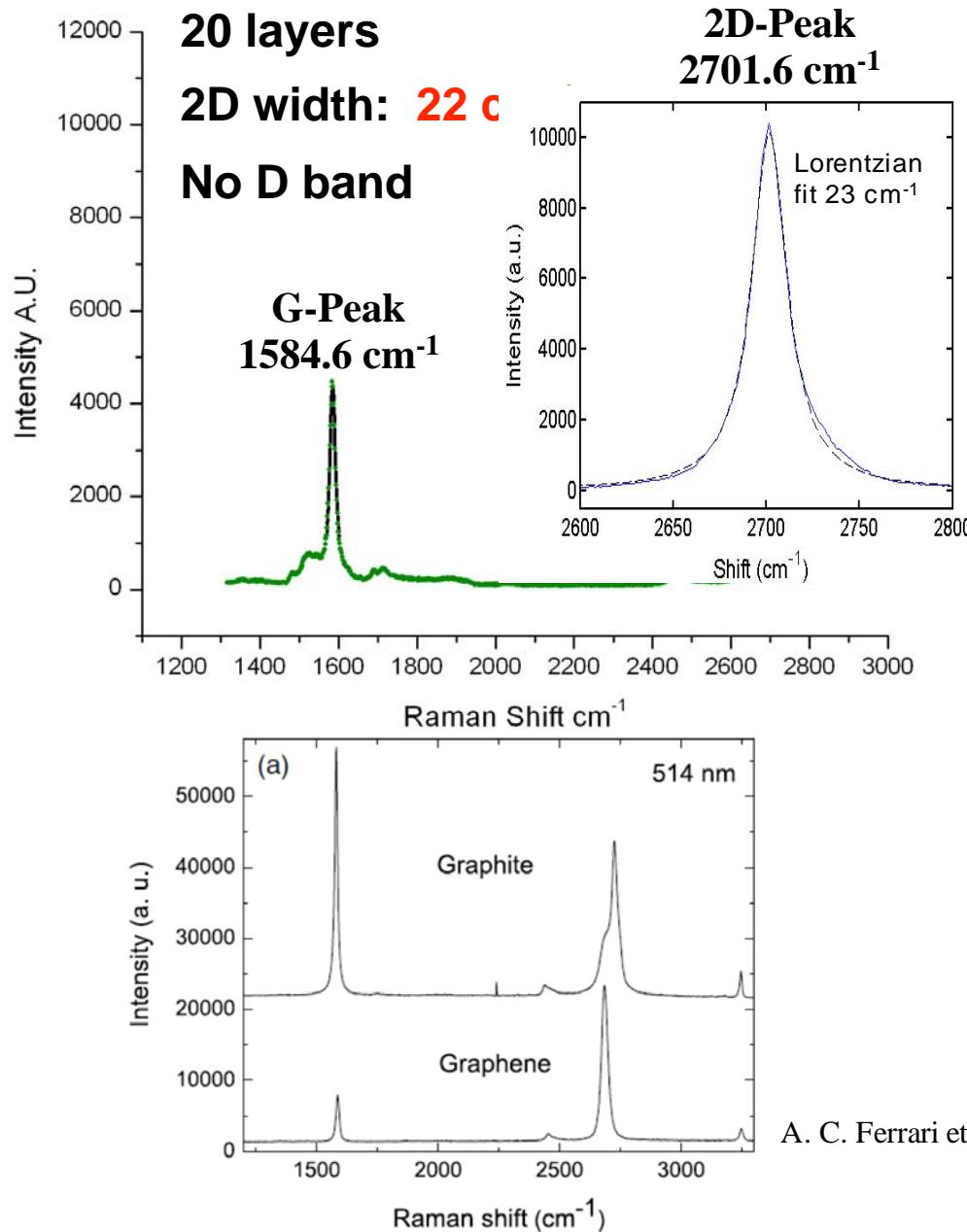
Furnace Growth  
C-face

At least one sheet continuously covers the entire surface

## Important notes on furnace grown epitaxial graphene.

1. The GIT furnace grown graphene crystals are exceptionally well-formed compared to UHV grown material with is of poor quality
2. At least the top layer is continuous over the entire surface making MEG graphene crystals by far the largest quasi 2D crystals known.
3. The number of layers varies (at most) by about 1 layer in well-made samples.
4. The interface layer is n doped and probably more disordered than the other layers.

# Raman Spectroscopy

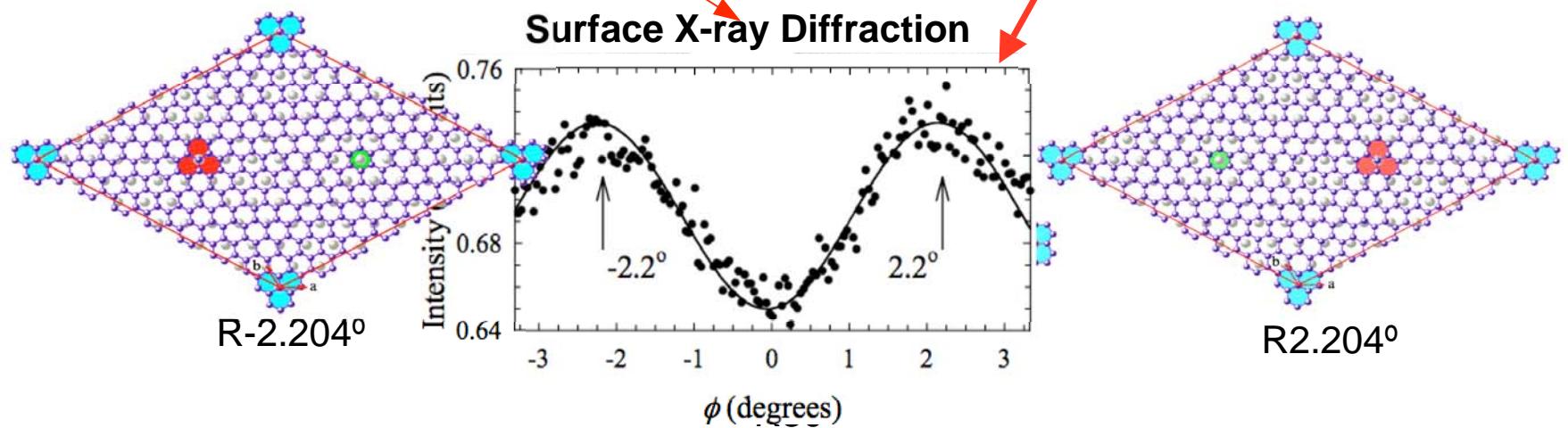
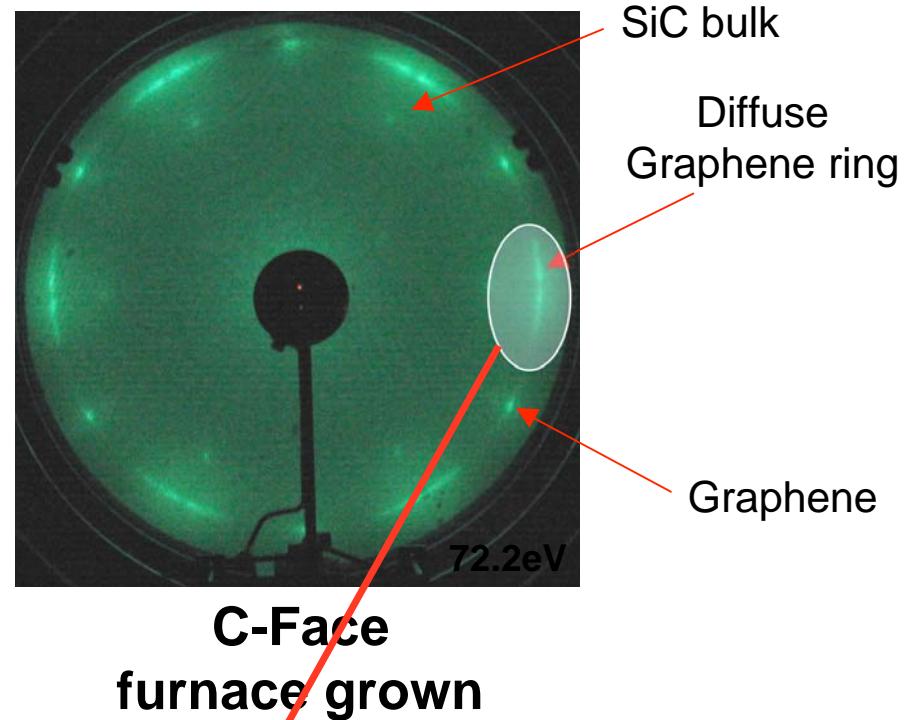
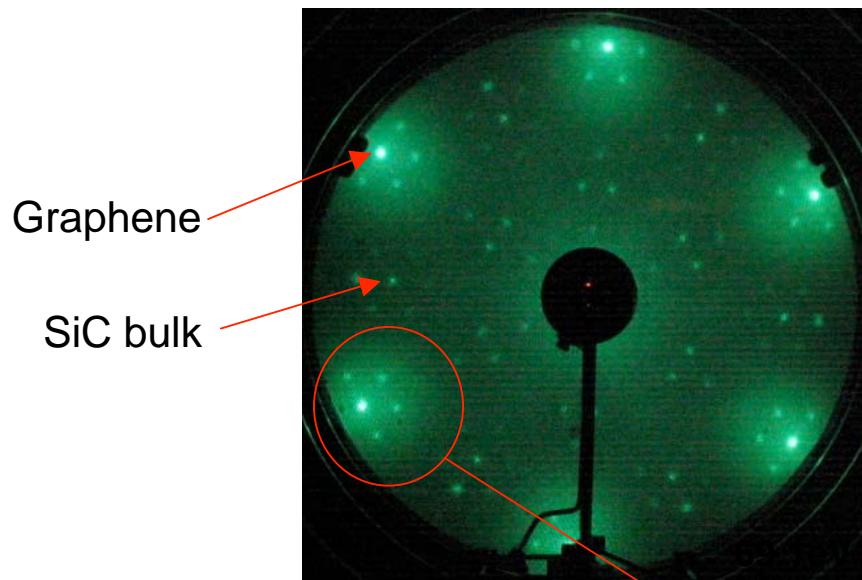


A. C. Ferrari et.al. PRL 97, 187401 (2006)

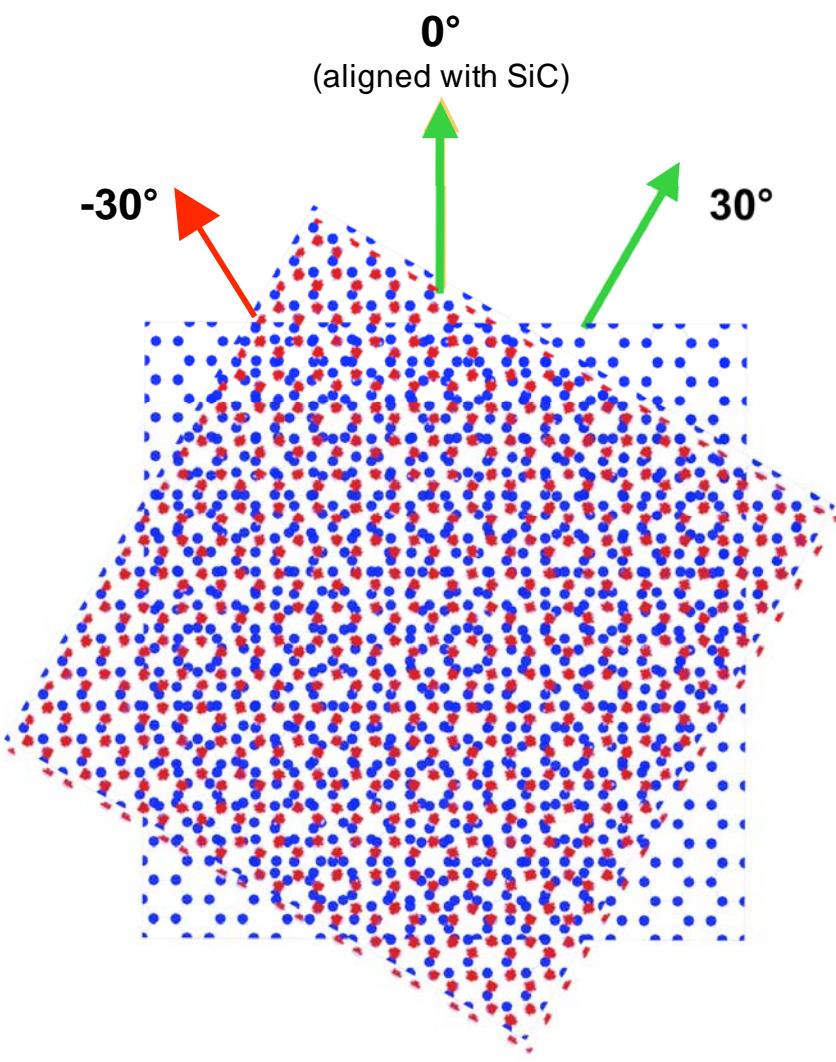
## **Stacking Si face: Bernal (AB)**

**C-face Rotational stacking  
(Multilayered epitaxial graphene)**

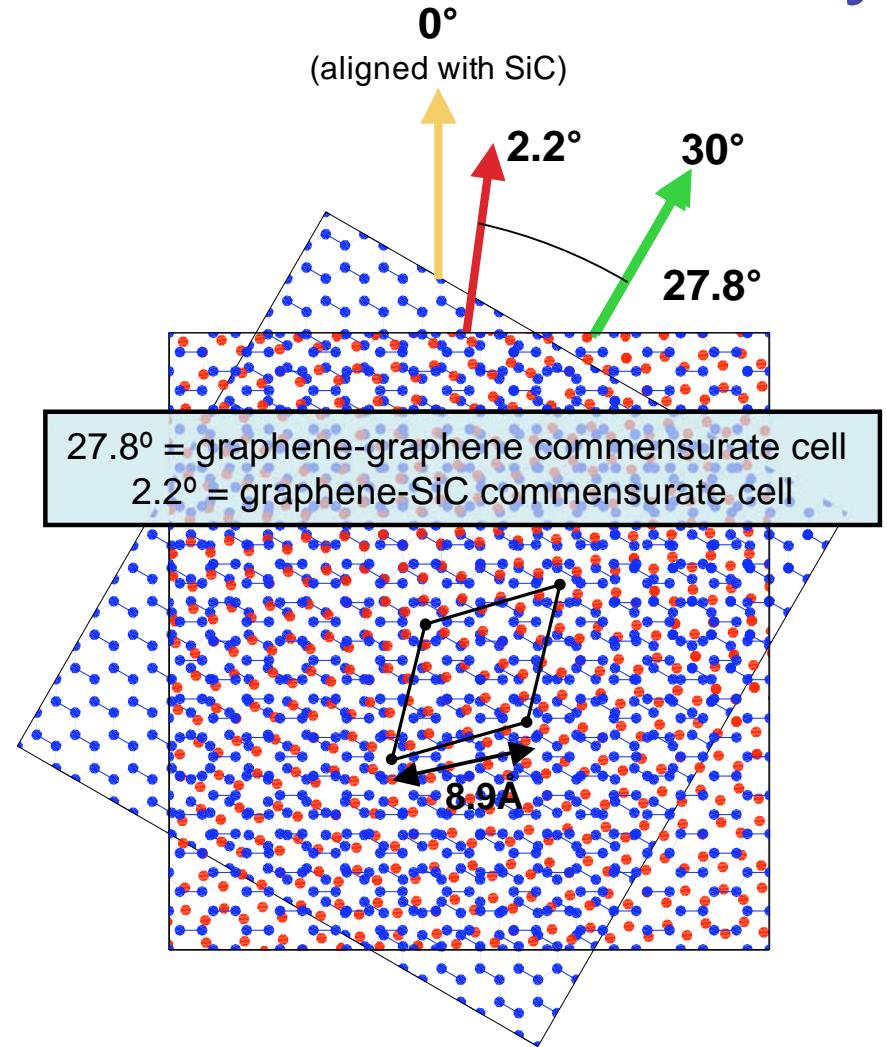
# Graphene/SiC Commensurability (LEED)



# Graphene/Graphene Commensurability

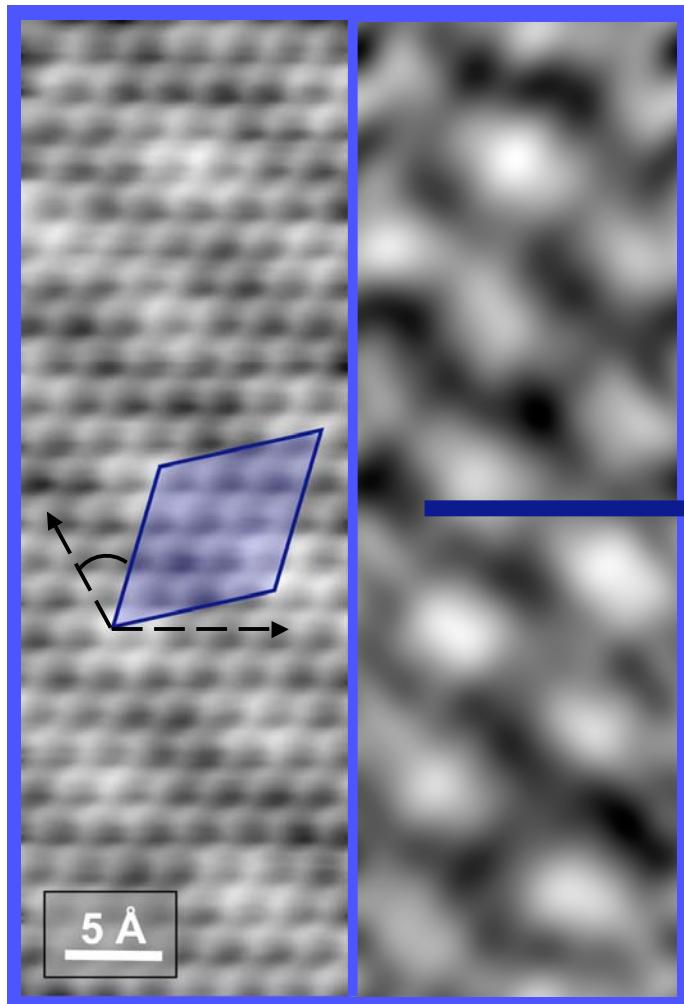


**Si-face**    **Graphite**  
**(AB stacked)**

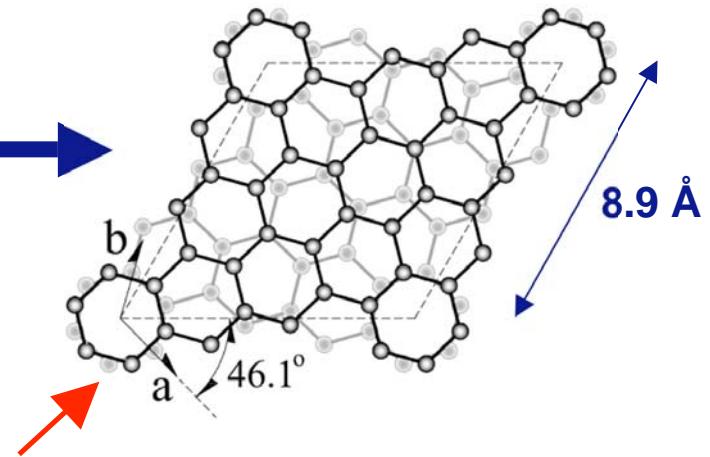


**C-face**  
**(rotated phases)**

# STM evidence for rotated phases



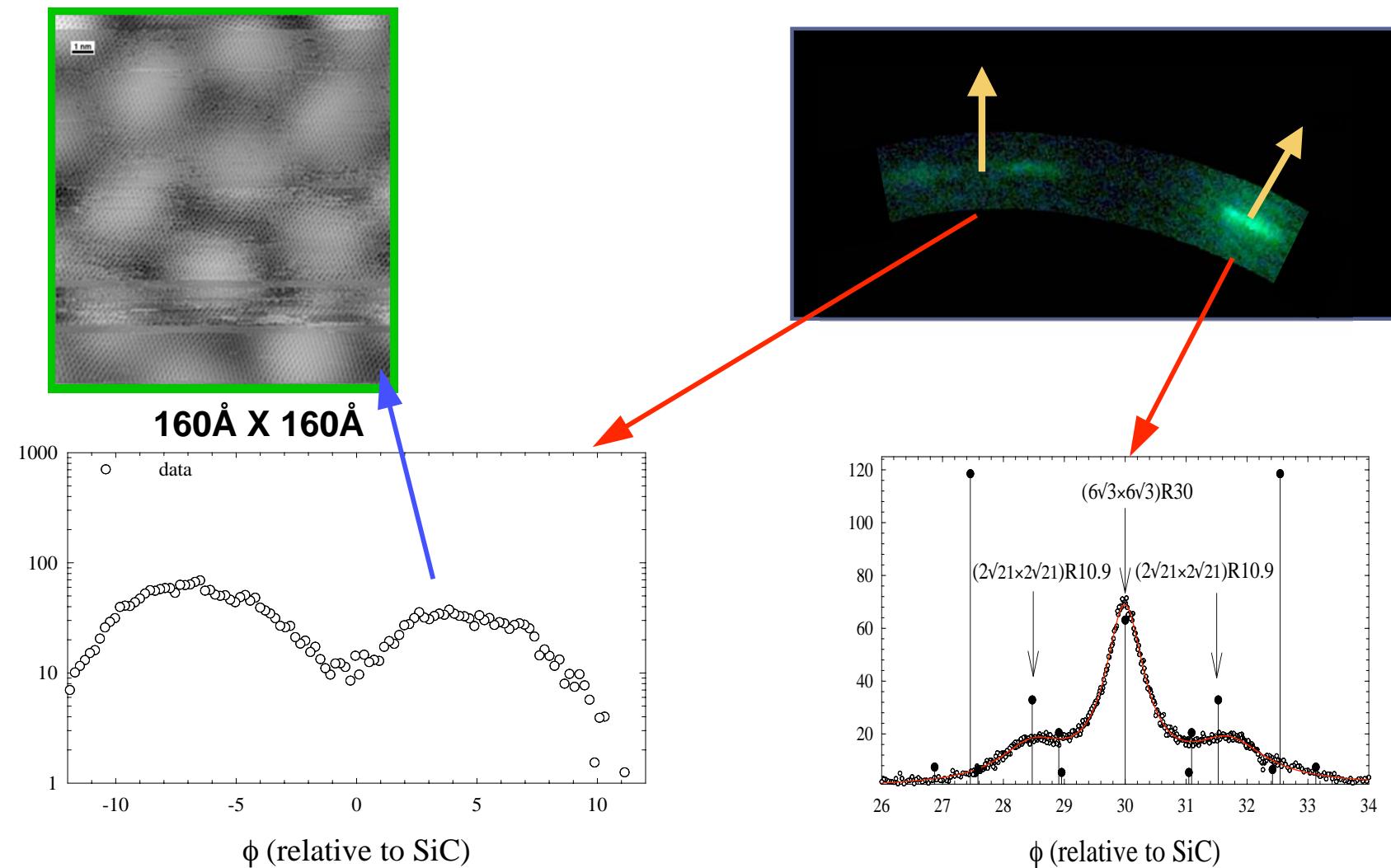
$(\sqrt{13} \times \sqrt{13})_G R46.1^\circ$

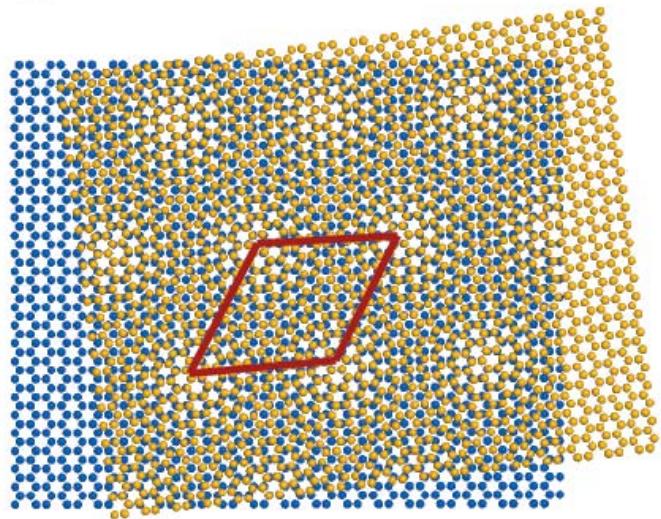
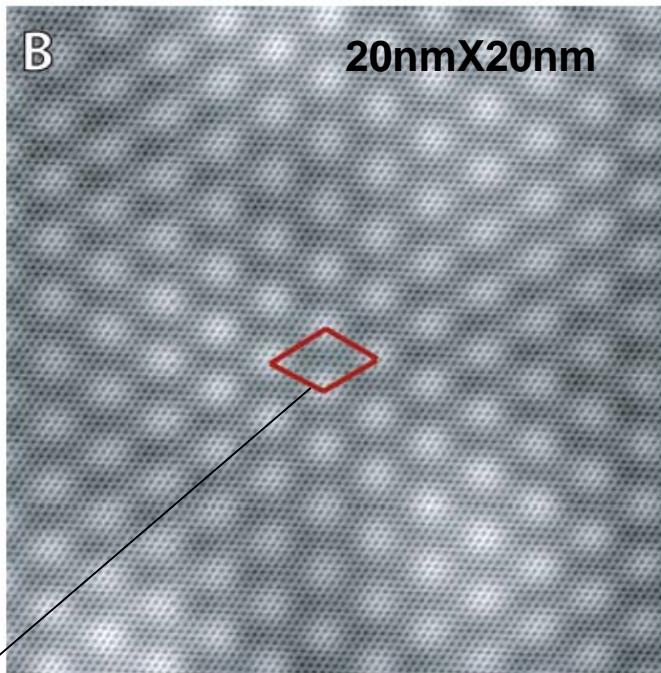


2 sheets with a relative rotation of 27.8°

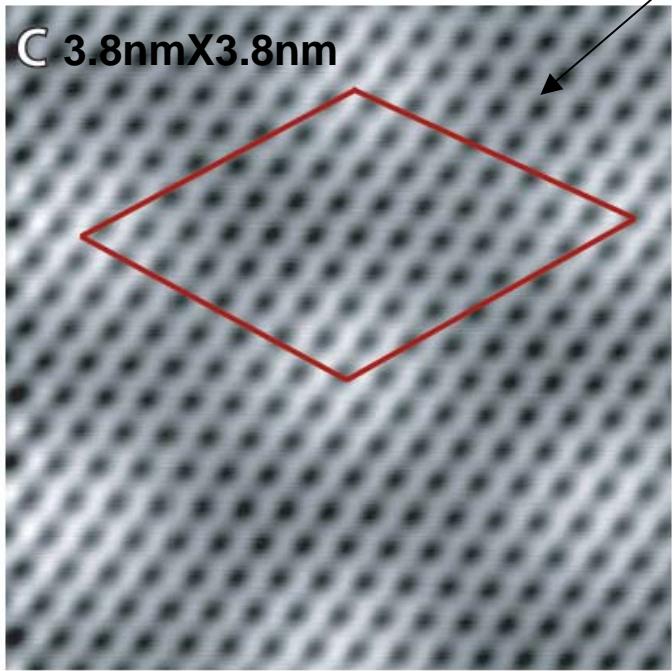
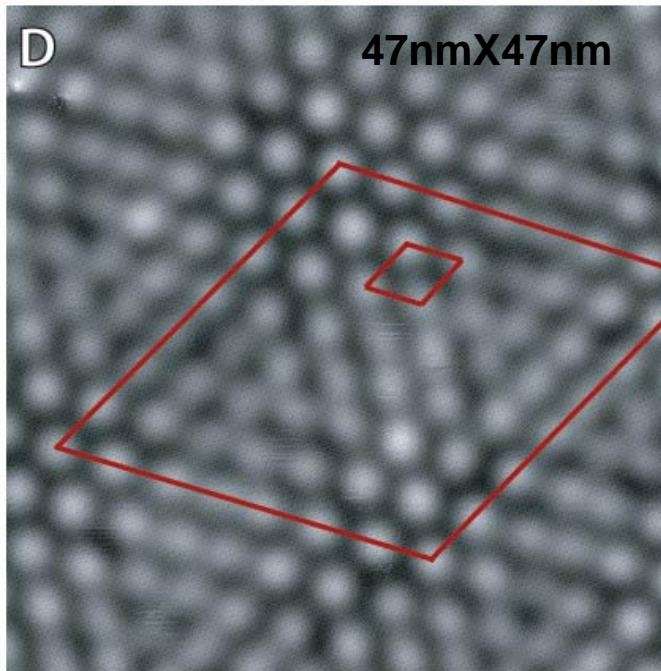
J. Hass, et al. Phys. Rev. Lett **100** 125504 (2008)

# Substrate induced rotations



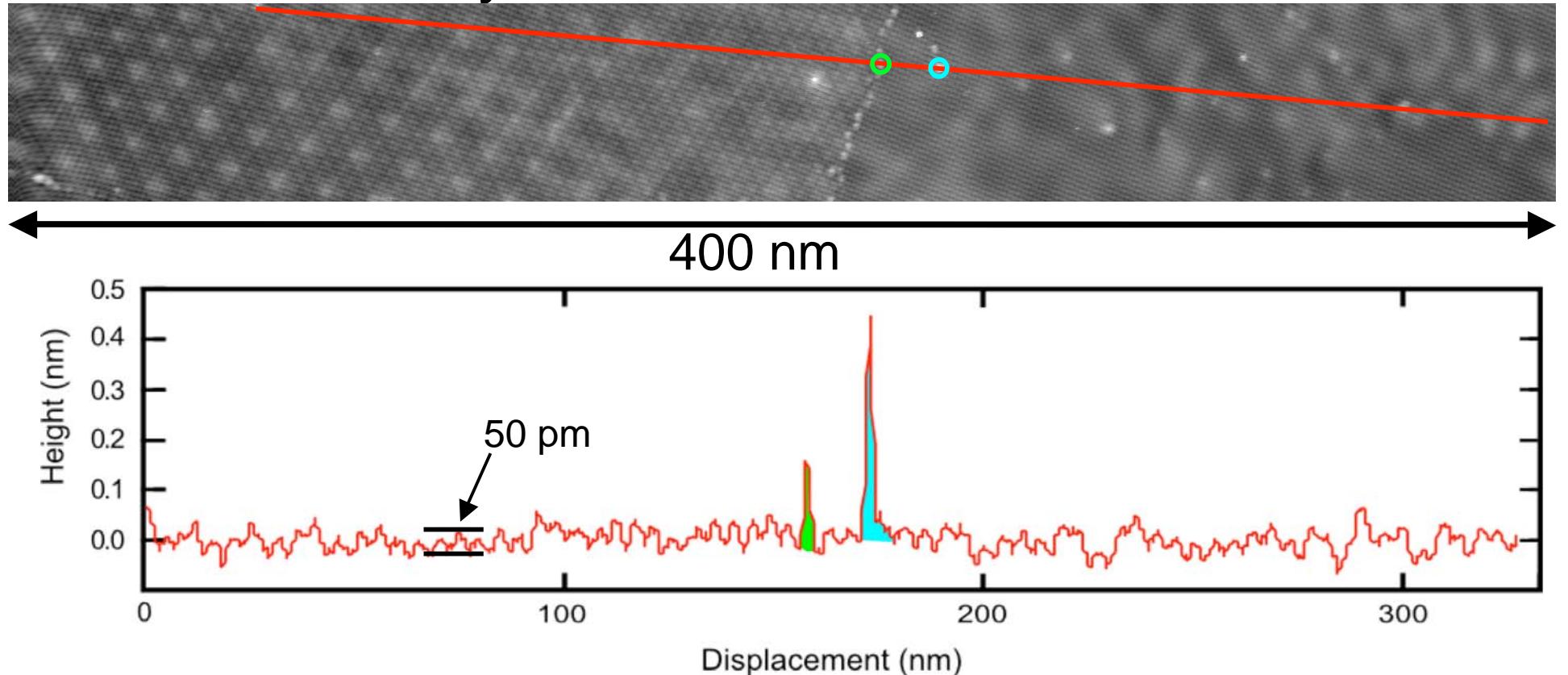
**A****B**

Miller et al  
Science, In print

**C 3.8nmX3.8nm****D**

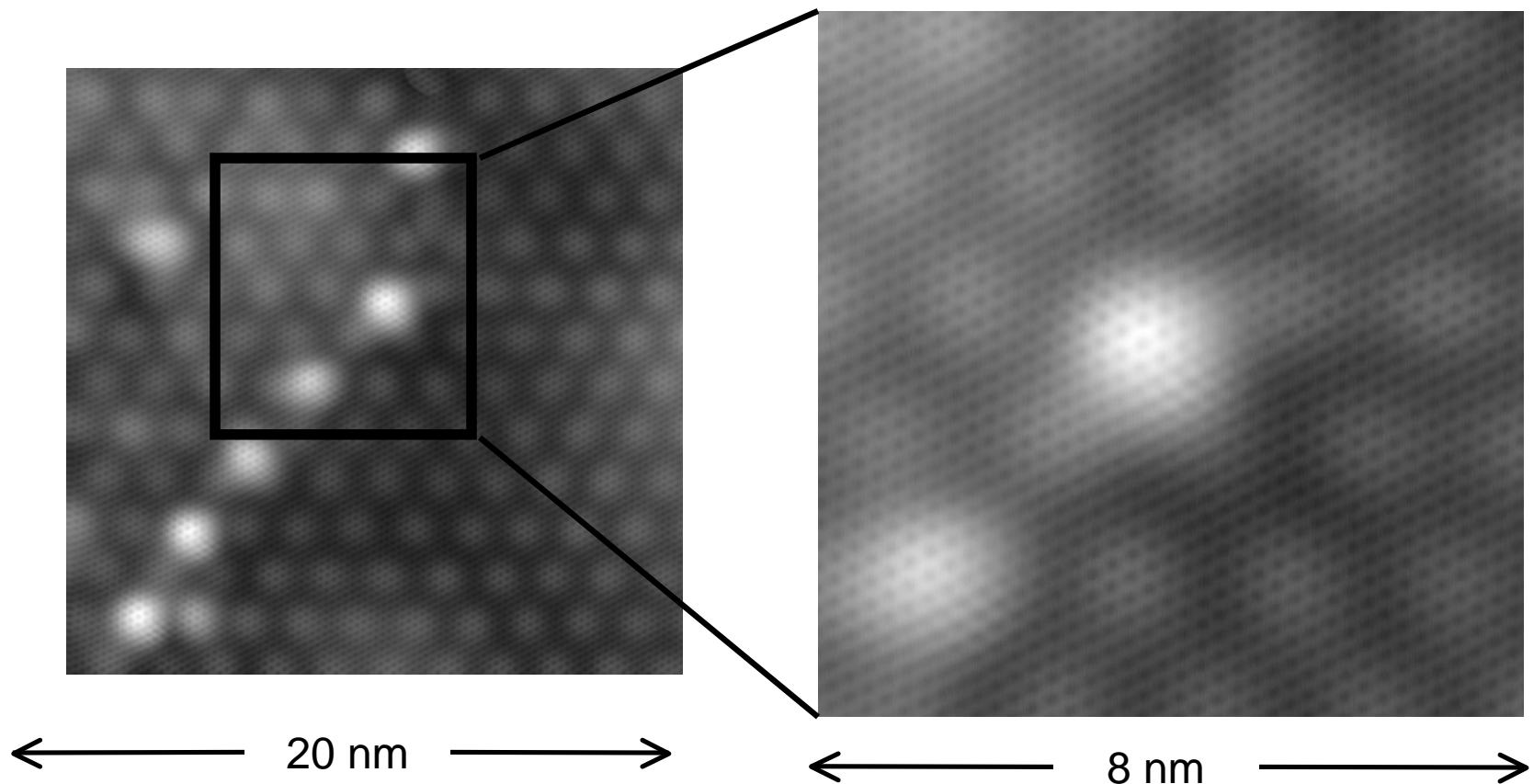
# Rotational Domain Boundaries

- Atomically flat and continuous across



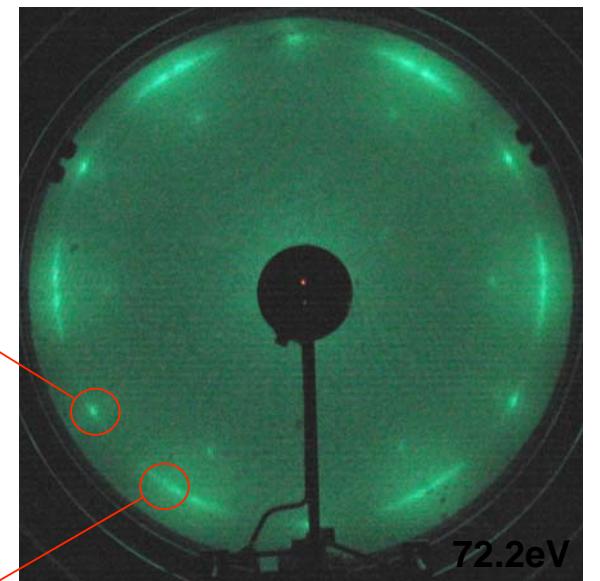
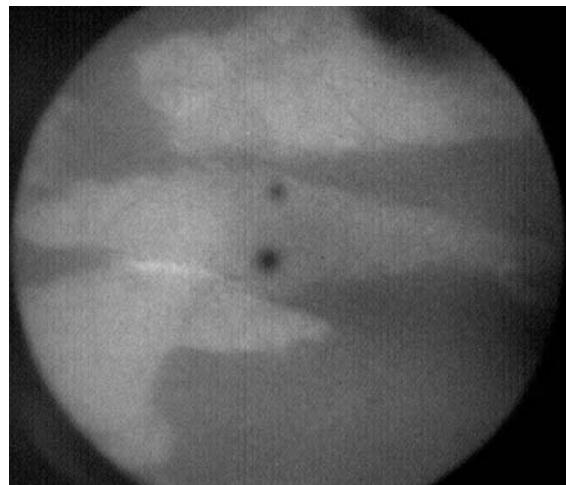
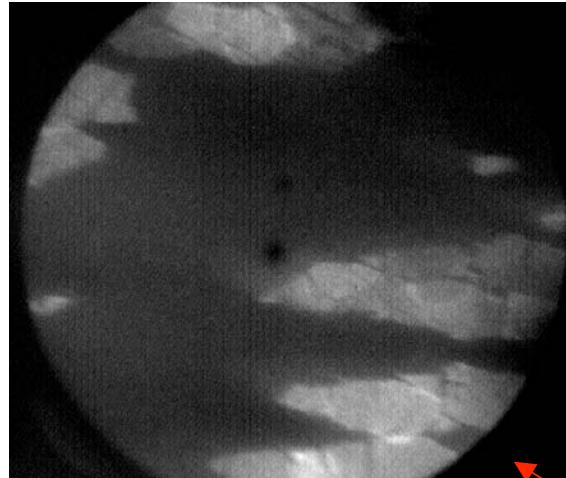
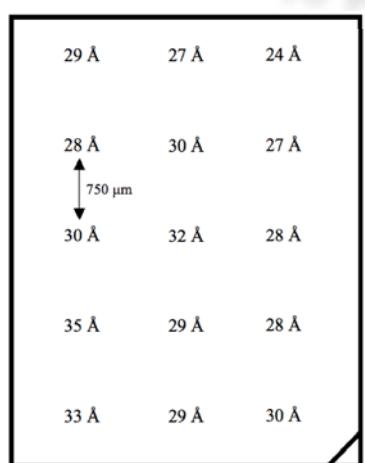
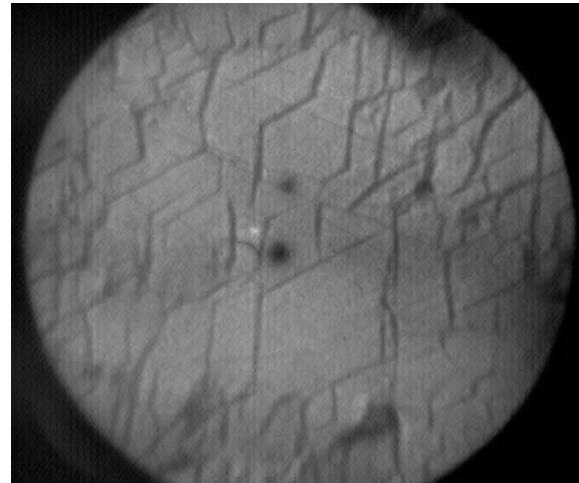
Joseph A. Stroscio email: [joseph.stroscio@nist.gov](mailto:joseph.stroscio@nist.gov)

# Rotational Domain Boundaries



Joseph A. Stroscio email: [joseph.stroscio@nist.gov](mailto:joseph.stroscio@nist.gov)

# Rotational domains (LEEM)



Ellipsometry thickness map:  
10±1 layer

E.Conrad, M.Sprinkle



# The Dirac cone

# Graphene band structure

PHYSICAL REVIEW

VOLUME 71, NUMBER 9

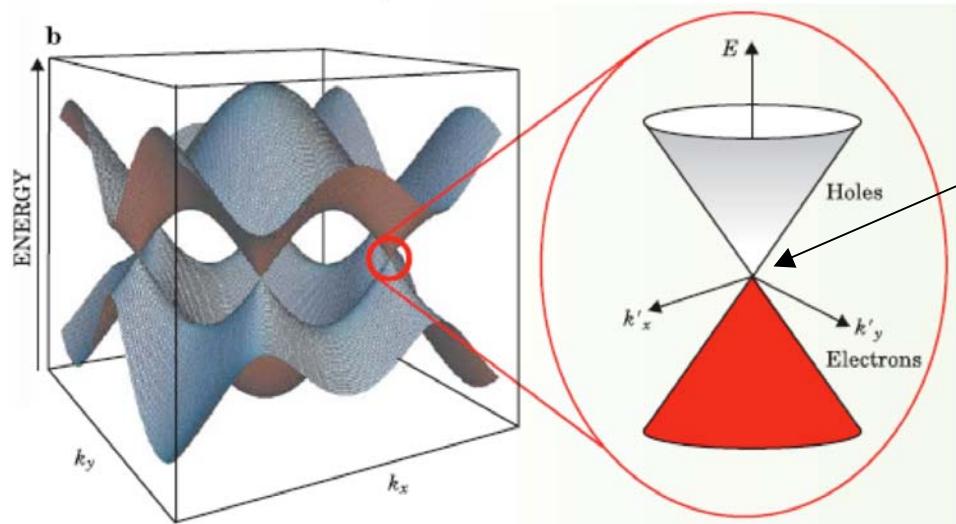
MAY 1, 1947

## The Band Theory of Graphite

P. R. WALLACE\*

National Research Council of Canada, Chalk River Laboratory, Chalk River, Ontario

(Received December 19, 1946)



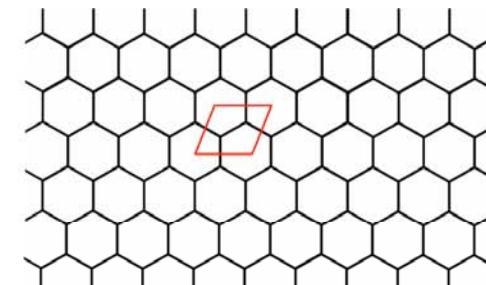
$$H = v_F \cdot \hat{\sigma} \cdot p$$

$$\hat{\sigma} = (\hat{\sigma}_x, \hat{\sigma}_y, \hat{\sigma}_z)$$

$$\sigma_x = \begin{pmatrix} 0 & 1 \\ 1 & 0 \end{pmatrix}; \sigma_y = \begin{pmatrix} 0 & -i \\ i & 0 \end{pmatrix}; \sigma_z = \begin{pmatrix} 1 & 0 \\ 0 & -1 \end{pmatrix}$$

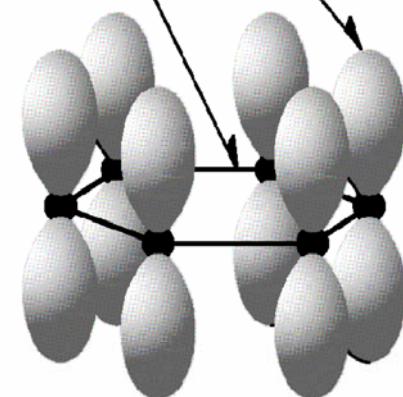
Velocity is constant

$$E = \pm v_F |p|$$



Dirac  
Point

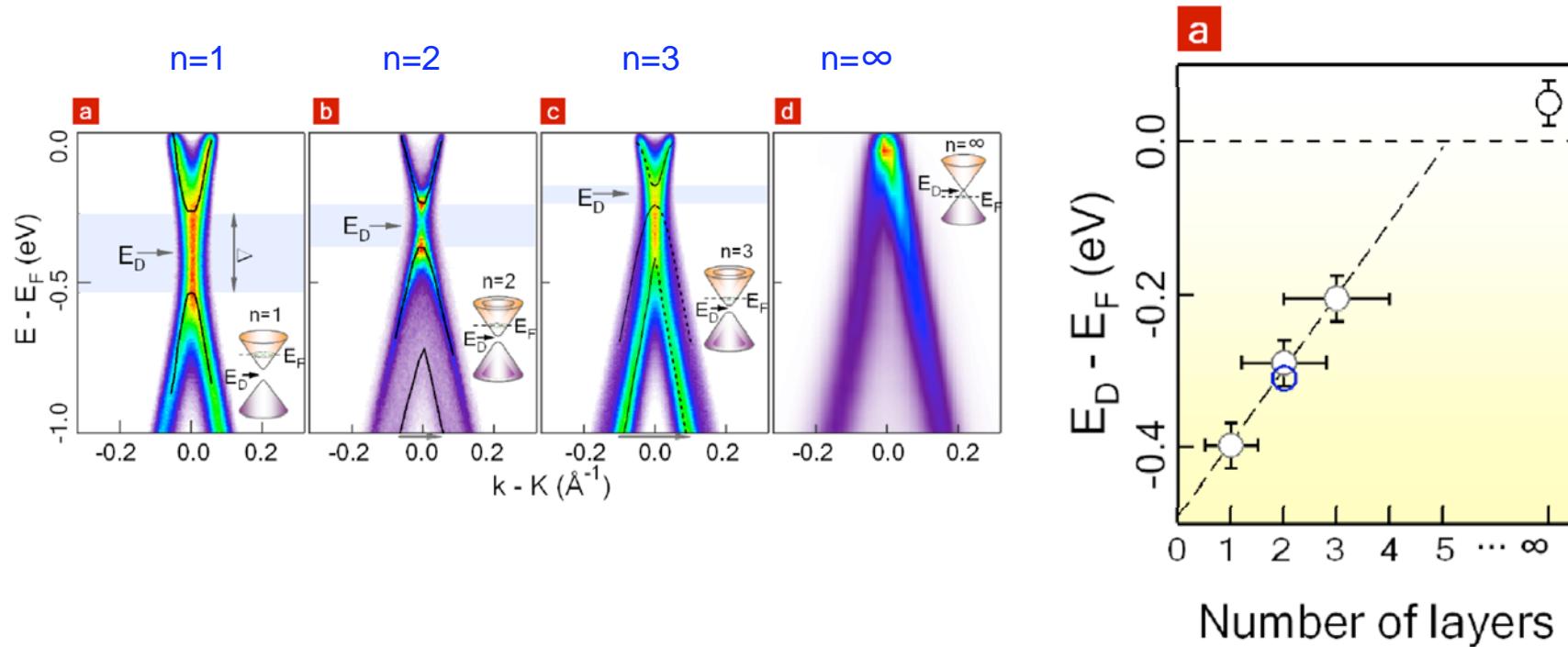
$\sigma$  bond  $\pi$  bond



Neutrino-like  
dispersion

# Substrate-induced band gap in Si-face EG

Zhou, Gweon, Fedorov, First, de Heer, Lee, Guinea., Castro Neto, Lanzara  
Nature Materials 6, 770-775 (2007)



Graphene on Si-face: gap is observed;  
Gap closes as the number of layers increases.

# Rotations preserve sublattice symmetry

PRL 100, 125504 (2008)

PHYSICAL REVIEW LETTERS

week ending  
28 MARCH 2008

## Why Multilayer Graphene on 4H-SiC(000̄1) Behaves Like a Single Sheet of Graphene

J. Hass,<sup>1</sup> F. Varchon,<sup>2</sup> J. E. Millán-Otoya,<sup>1</sup> M. Sprinkle,<sup>1</sup> N. Sharma,<sup>1</sup> W. A. de Heer,<sup>1</sup> C. Berger,<sup>1,2</sup>  
P. N. First,<sup>1</sup> L. Magaud,<sup>2</sup> and E. H. Conrad<sup>1</sup>

<sup>1</sup>The Georgia Institute of Technology, Atlanta, Georgia 30332-0430, USA

<sup>2</sup>Institut Néel/CNRS-UJF BP166, 38042 Grenoble Cedex 9, France

(Received 13 June 2007; published 28 March 2008)

PRL 99, 256802 (2007)

PHYSICAL REVIEW LETTERS

week ending  
21 DECEMBER 2007

## Graphene Bilayer with a Twist: Electronic Structure

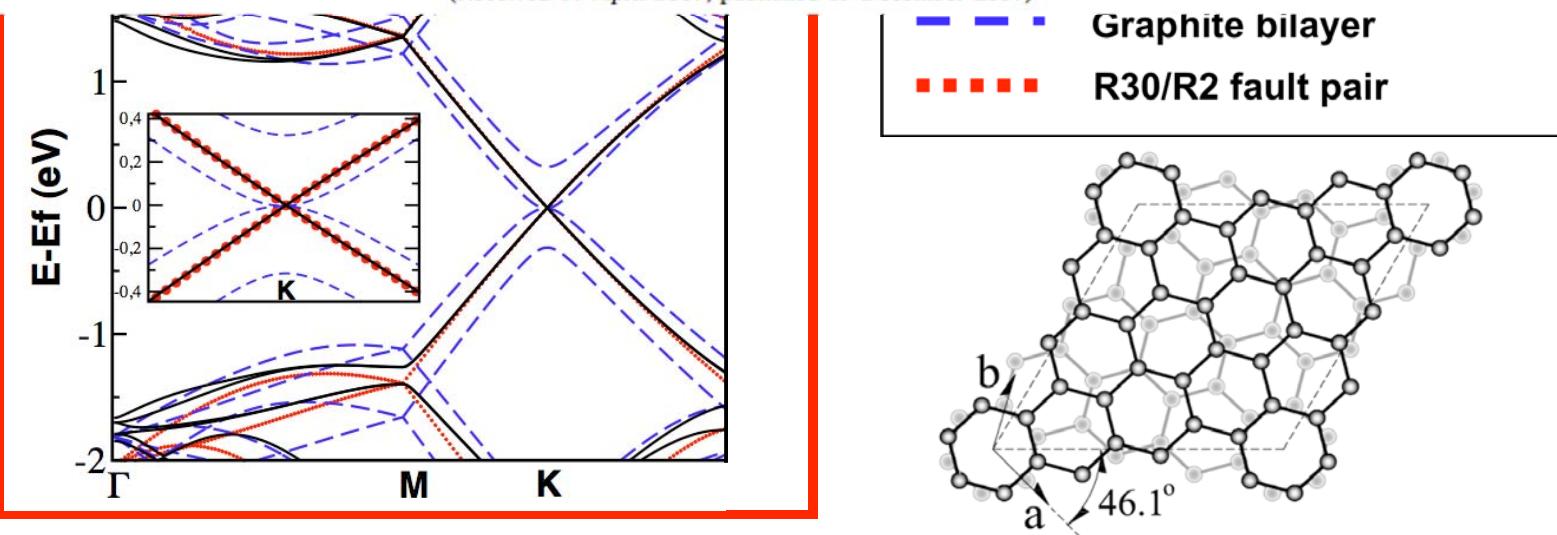
J. M. B. Lopes dos Santos,<sup>1</sup> N. M. R. Peres,<sup>2</sup> and A. H. Castro Neto<sup>3</sup>

<sup>1</sup>CFP and Departamento de Física, Faculdade de Ciências, Universidade do Porto, 4169-007 Porto, Portugal

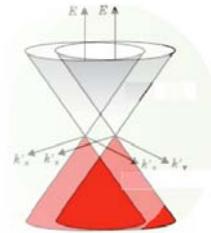
<sup>2</sup>Centro de Física and Departamento de Física, Universidade do Minho, P-4710-057 Braga, Portugal

<sup>3</sup>Department of Physics, Boston University, 590 Commonwealth Avenue, Boston, Massachusetts 02215, USA

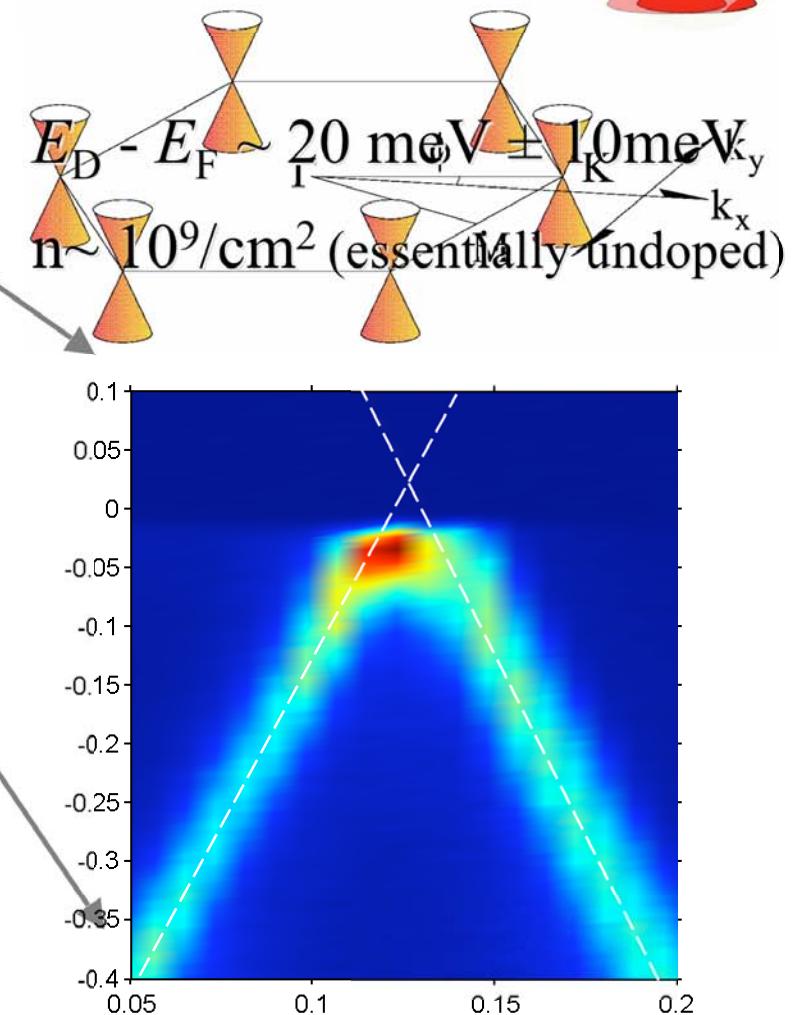
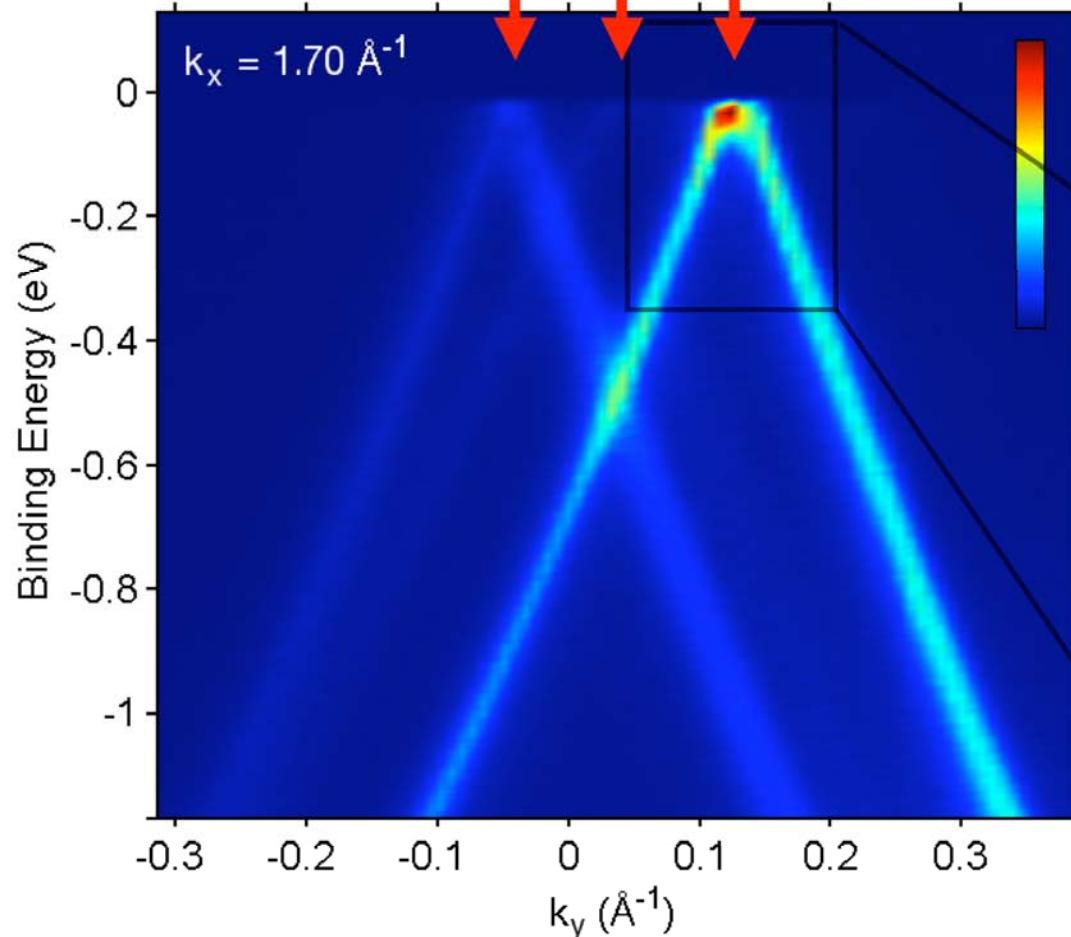
(Received 17 April 2007; published 19 December 2007)



# ARPES: MEG (C-face)

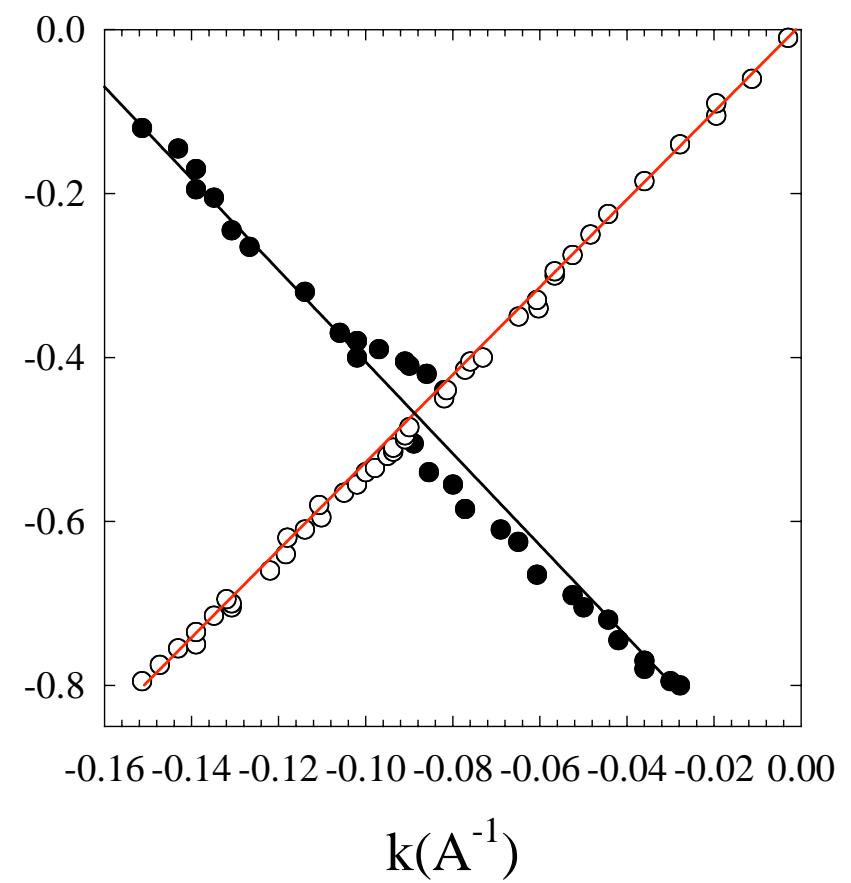
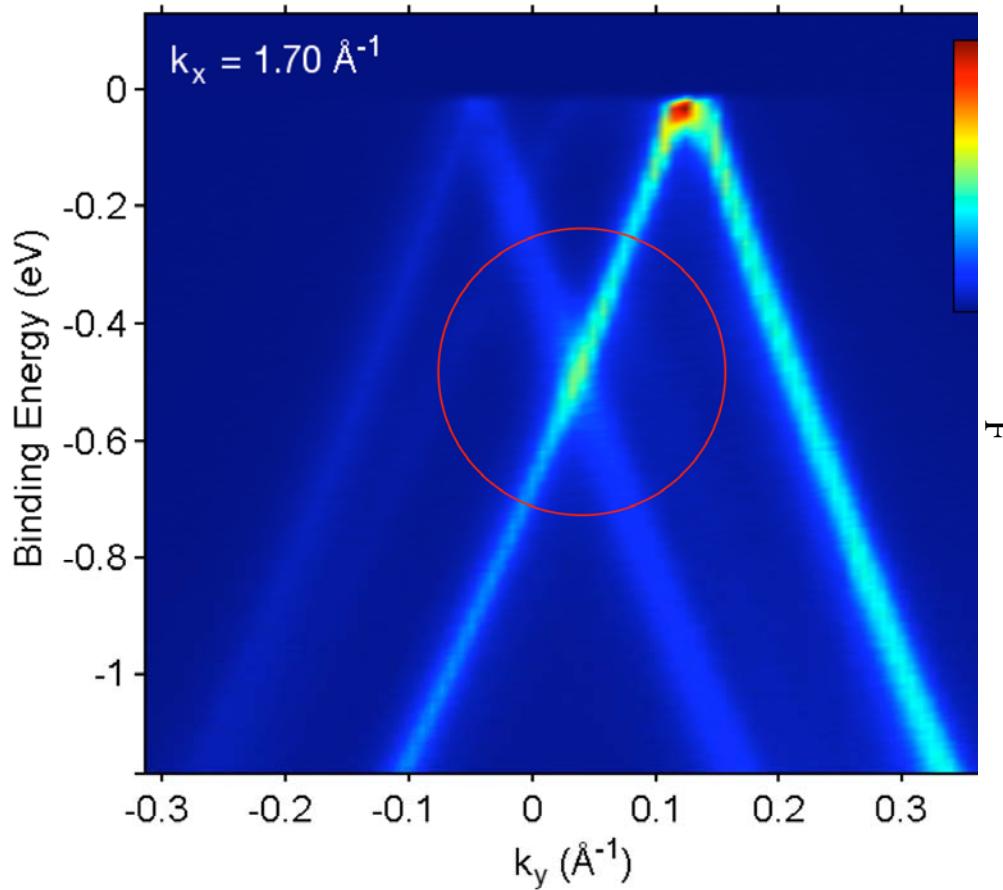


T=6K; near K-point



Each rotated sheet displays linear dispersion!

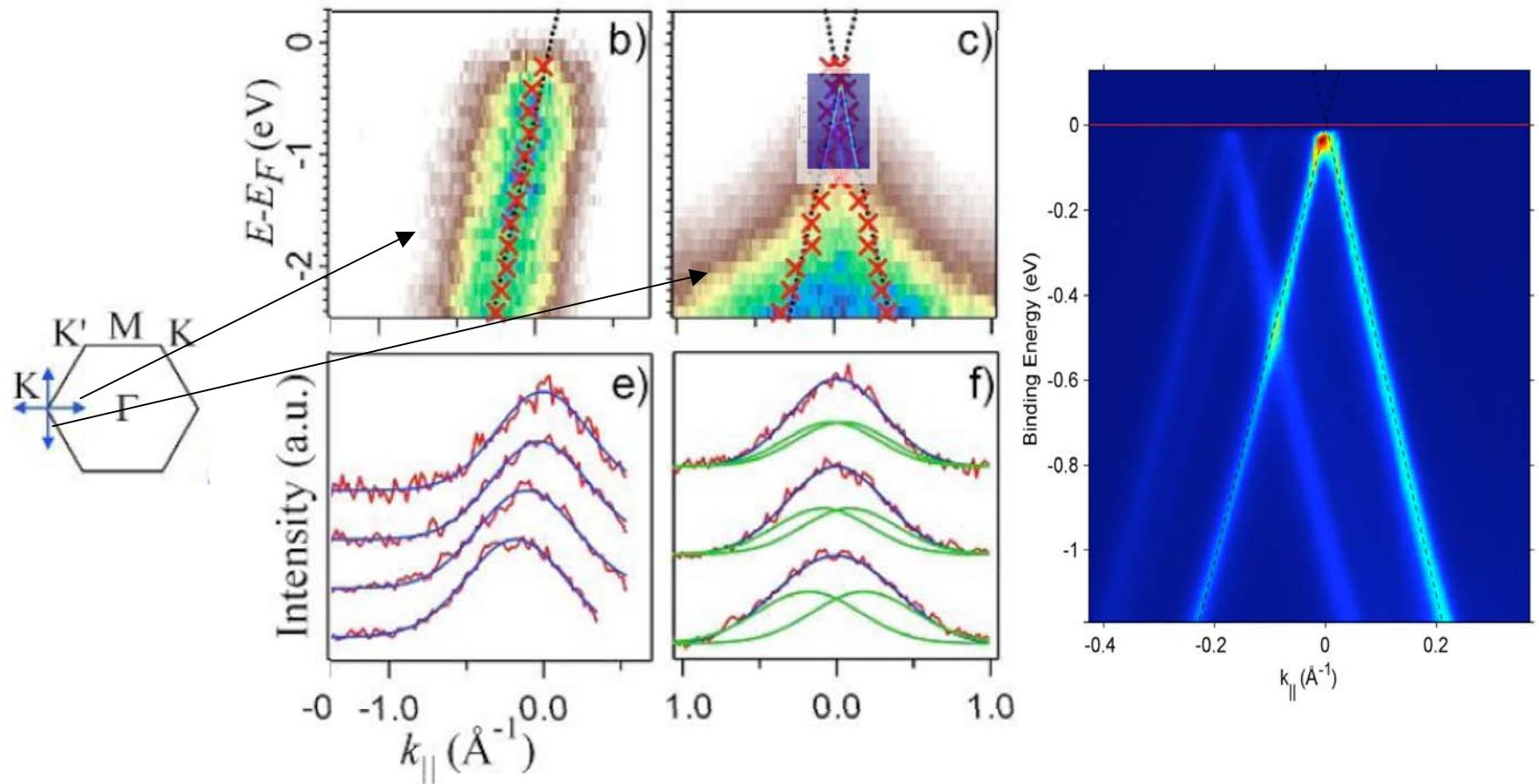
# Layer Interactions (MEG)



These two sheets are  $\sim 3 - 4 \text{\AA}$  apart

# Spectro-microscopy of single and multi-layer graphene supported by a weakly interacting substrate

Knox, Wang, Morgante, Cvetko, Locatelli, Onur Mentes, Angel Ni, Philip Kim, Osgood



*ARPES of exfoliated graphene:  
does it have a Dirac point?*

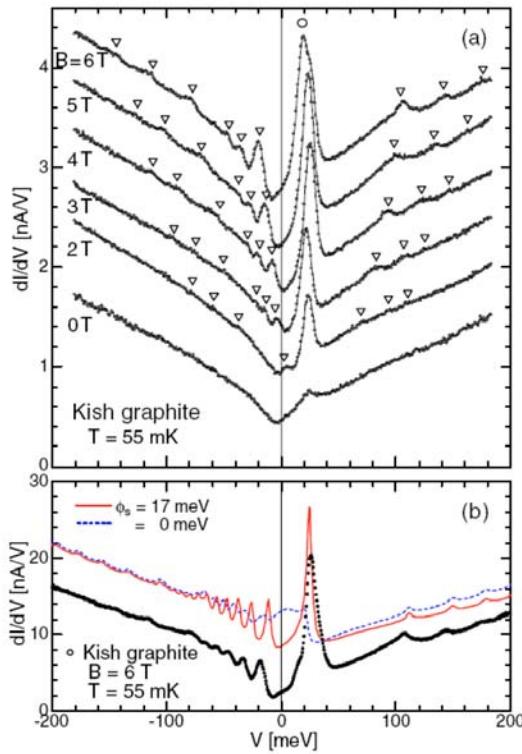
# Scanning tunneling spectroscopy of Landau levels

**Observing the Quantization of Zero  
Mass Carriers in  
(Multilayer Epitaxial ) Graphene**

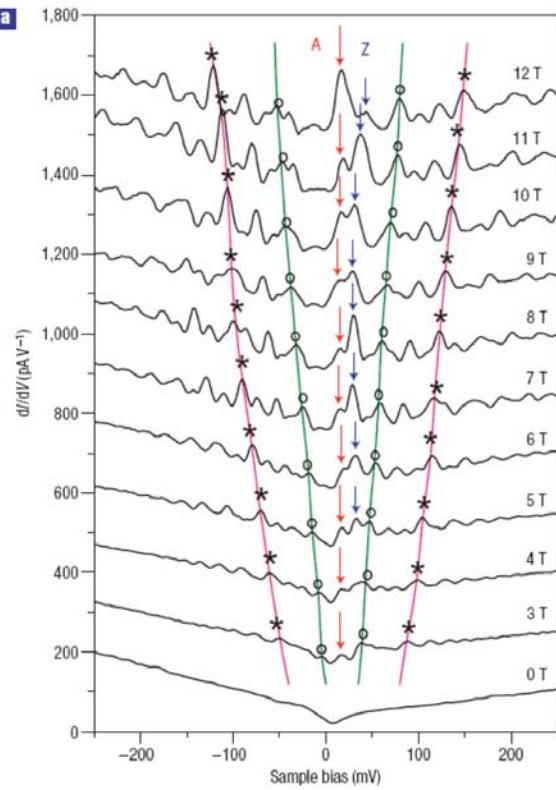
*Science In Press*

*D.L. Miller, K. D. Kubista, G. M. Rutter, M.Ruan,  
Walt A. de Heer, P. N. First,  
J. A. Stroscio  
(NIST, GIT)*

# Previous STS Measurements on Graphite Surfaces



T. Matsui et al. PRL (2005)

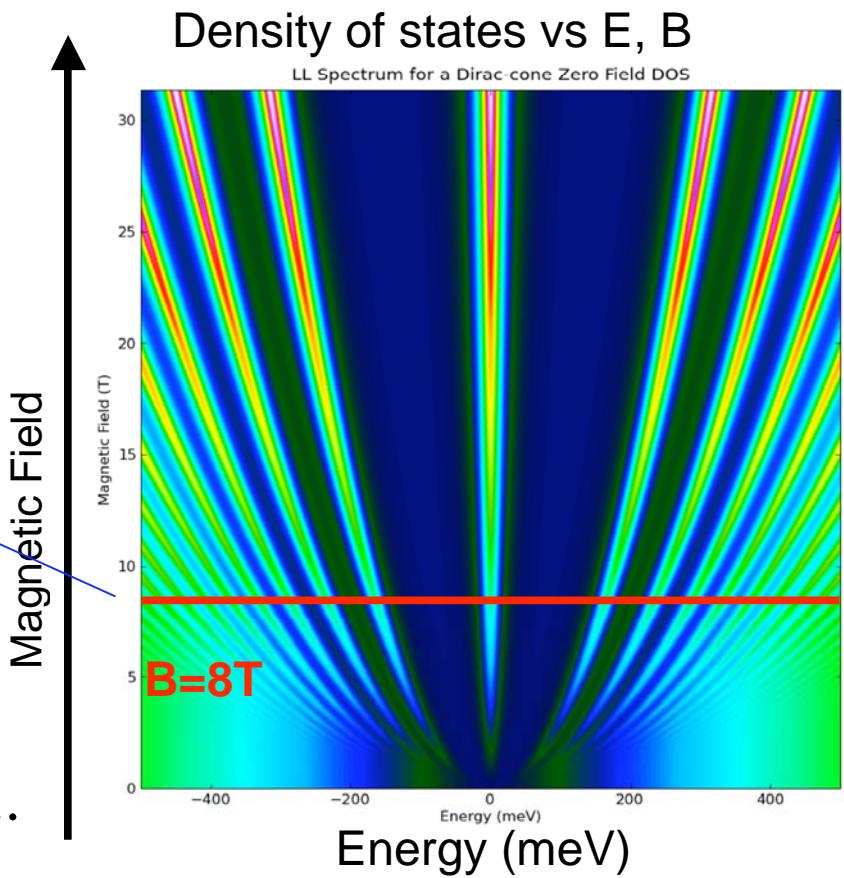
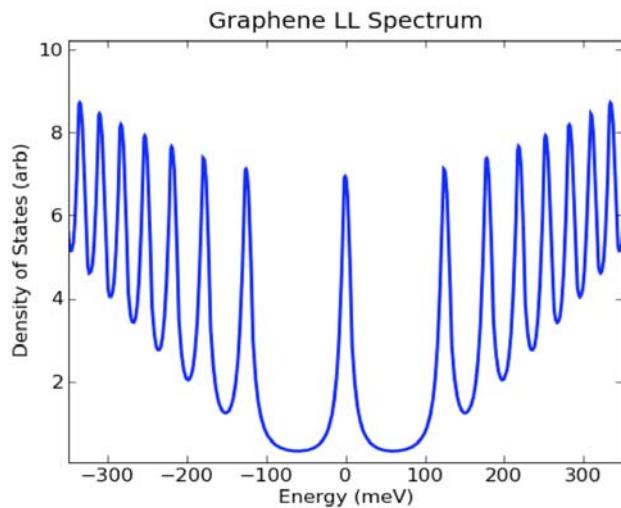


G. Li and E. Andrei  
Nature Phys. (2007)

- Complex spectra
- Mixture of peaks of linear and non-linear in  $B$

Courtesy Joe Stroscio

# Landau Levels in Graphene



$$E_n = \text{sgn}(n) \sqrt{2e\hbar\tilde{c}^2 |n| B} \quad n=0, \pm 1, \dots$$

Graphene

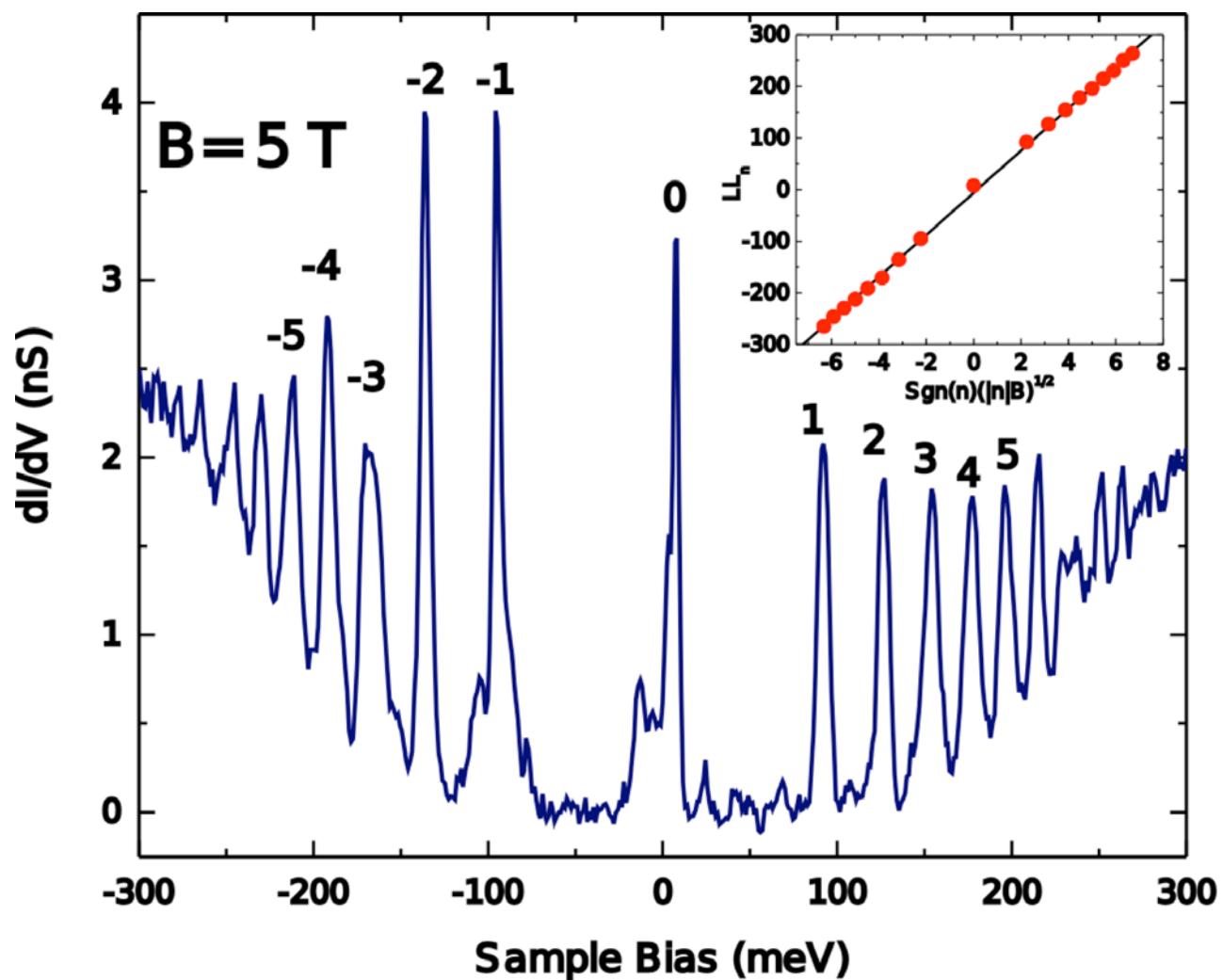
$$E_n = \frac{\hbar e B}{m^*} (n + 1/2) \quad n \geq 0$$

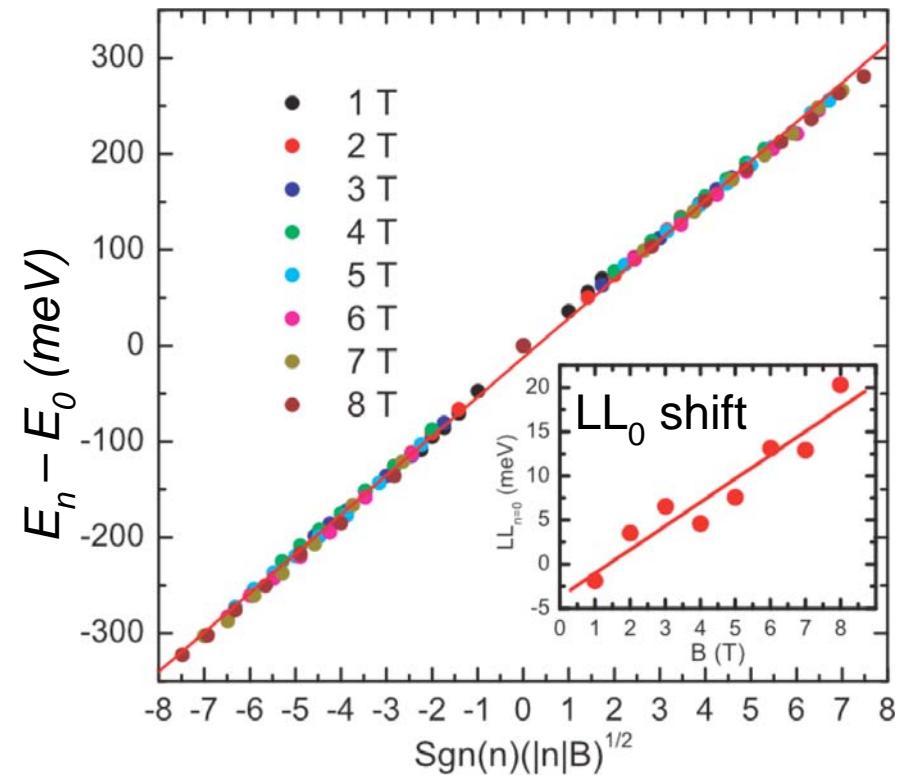
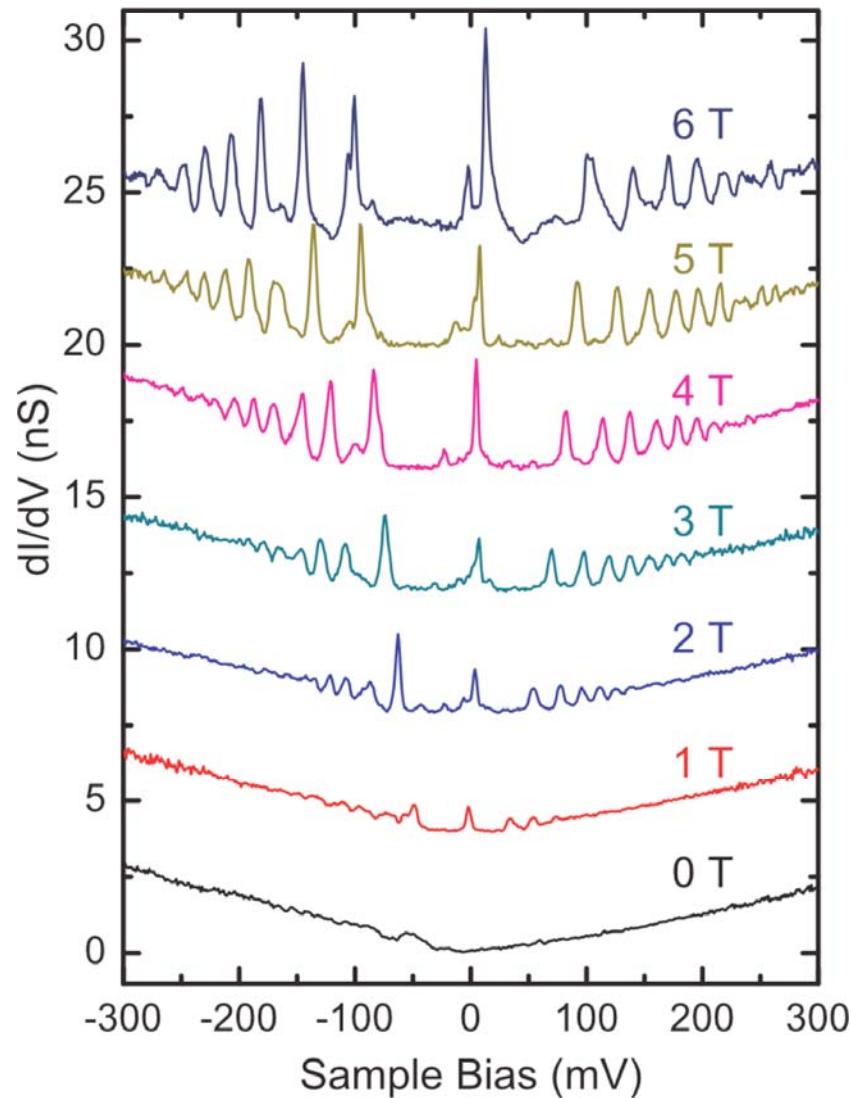
Standard 2DEG

Courtesy P.N.Firsov

# STS

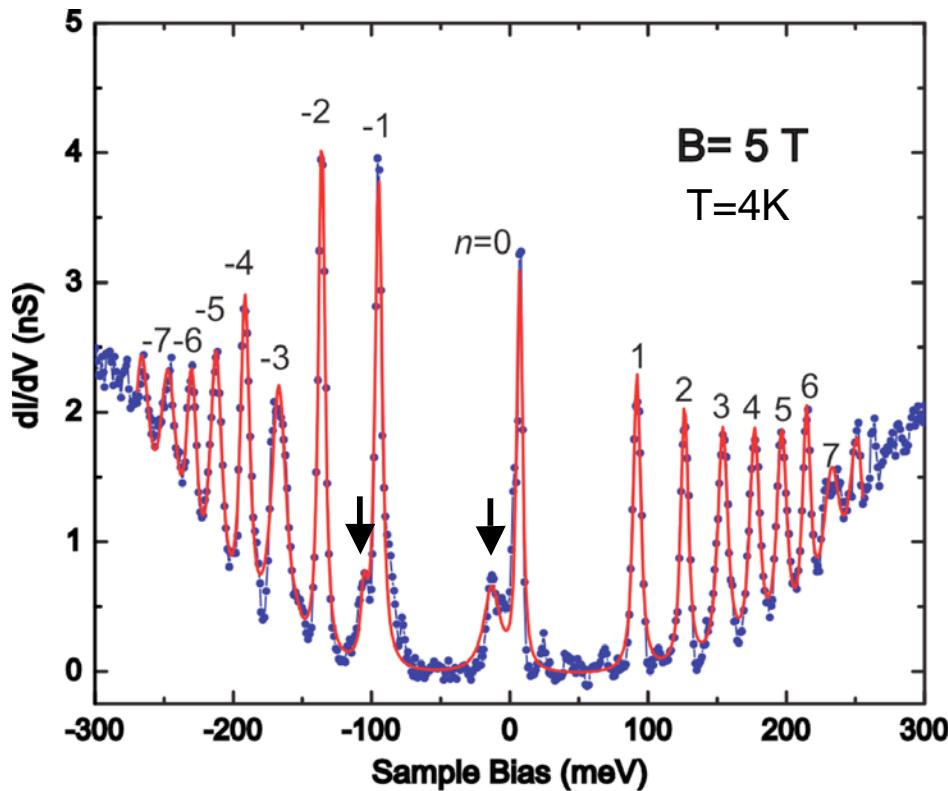
## Multilayer Epitaxial Graphene: Landau Levels





$$c^* = 1.13 \times 10^6 \text{ m/s}$$

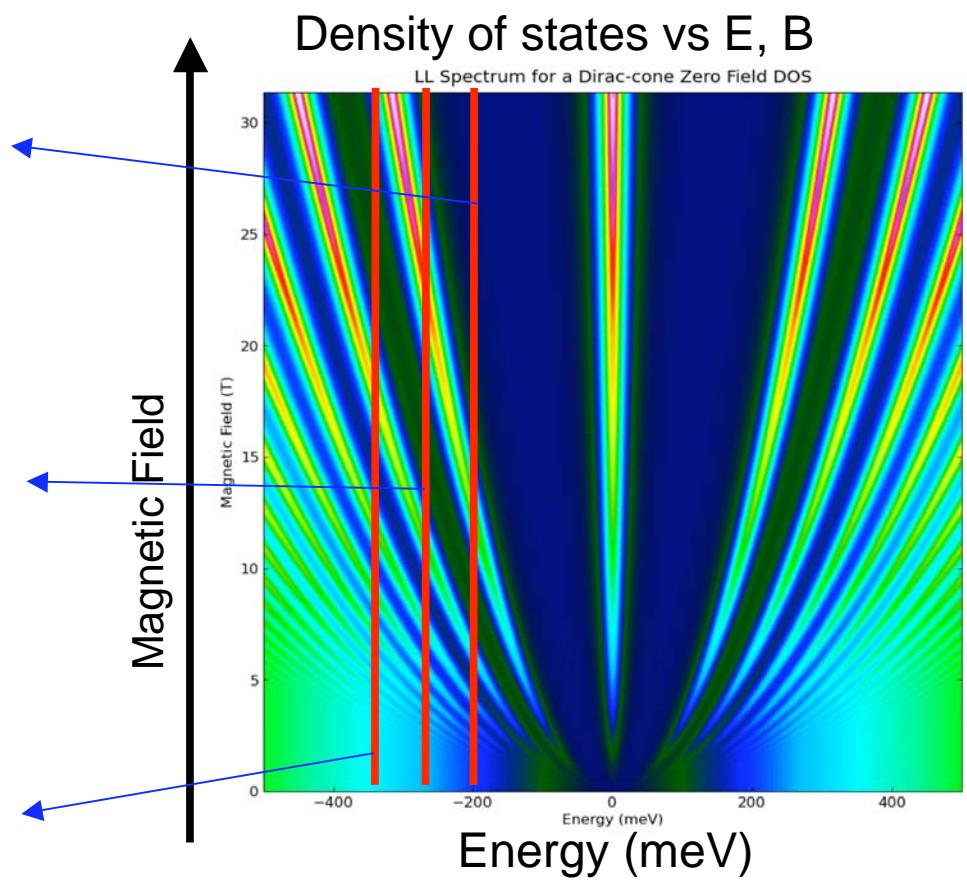
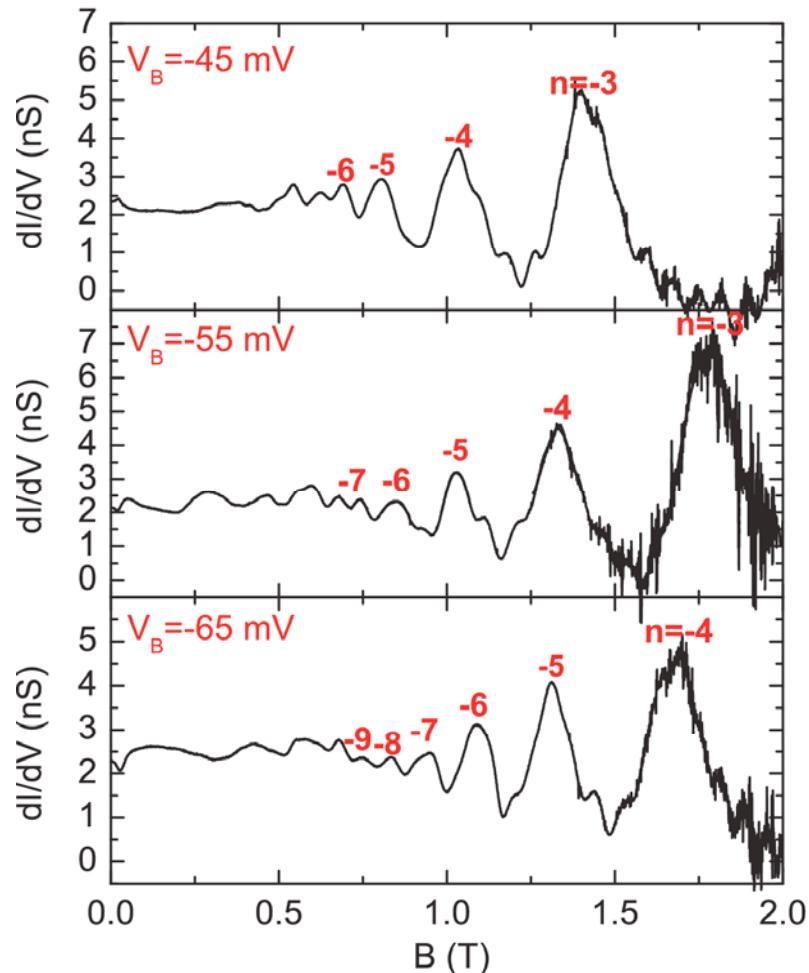
# Landau Level Fit



- Simple sum of Voigt functions (Gaussian, Lorentzian convolution)
- Gaussian: 2.8 meV (instrument function + thermal broadening; *fixed*)
- $\text{LL}_0$  Lorentzian: 1.5 meV (0.4 ps lifetime: lower limit to momentum relaxation time)

# Tunneling Magnetoconductance Oscillations

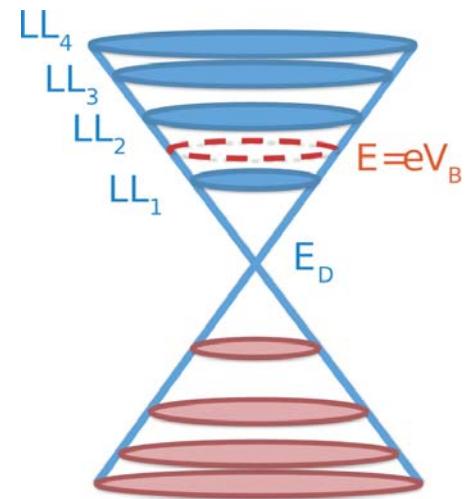
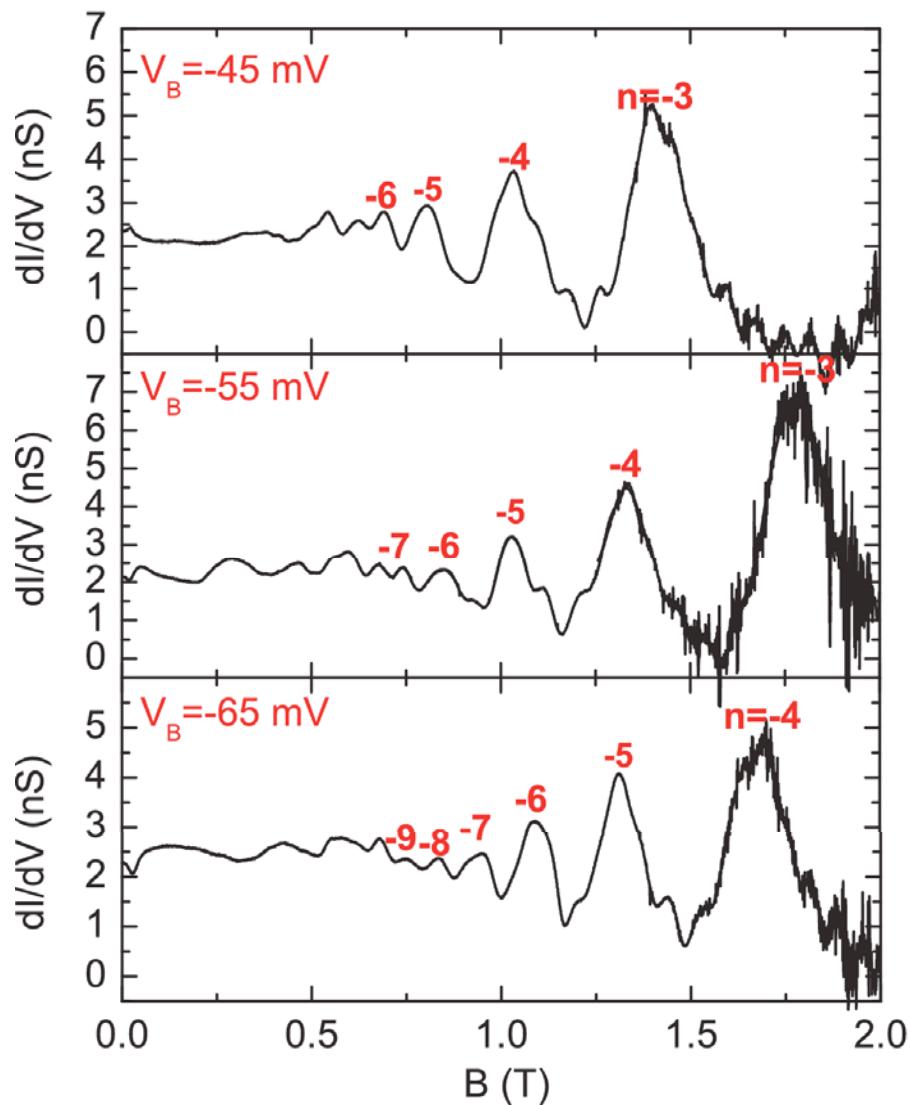
(~SdH oscillations, but not restricted to  $E_F$ )



Courtesy P.N.Firsov

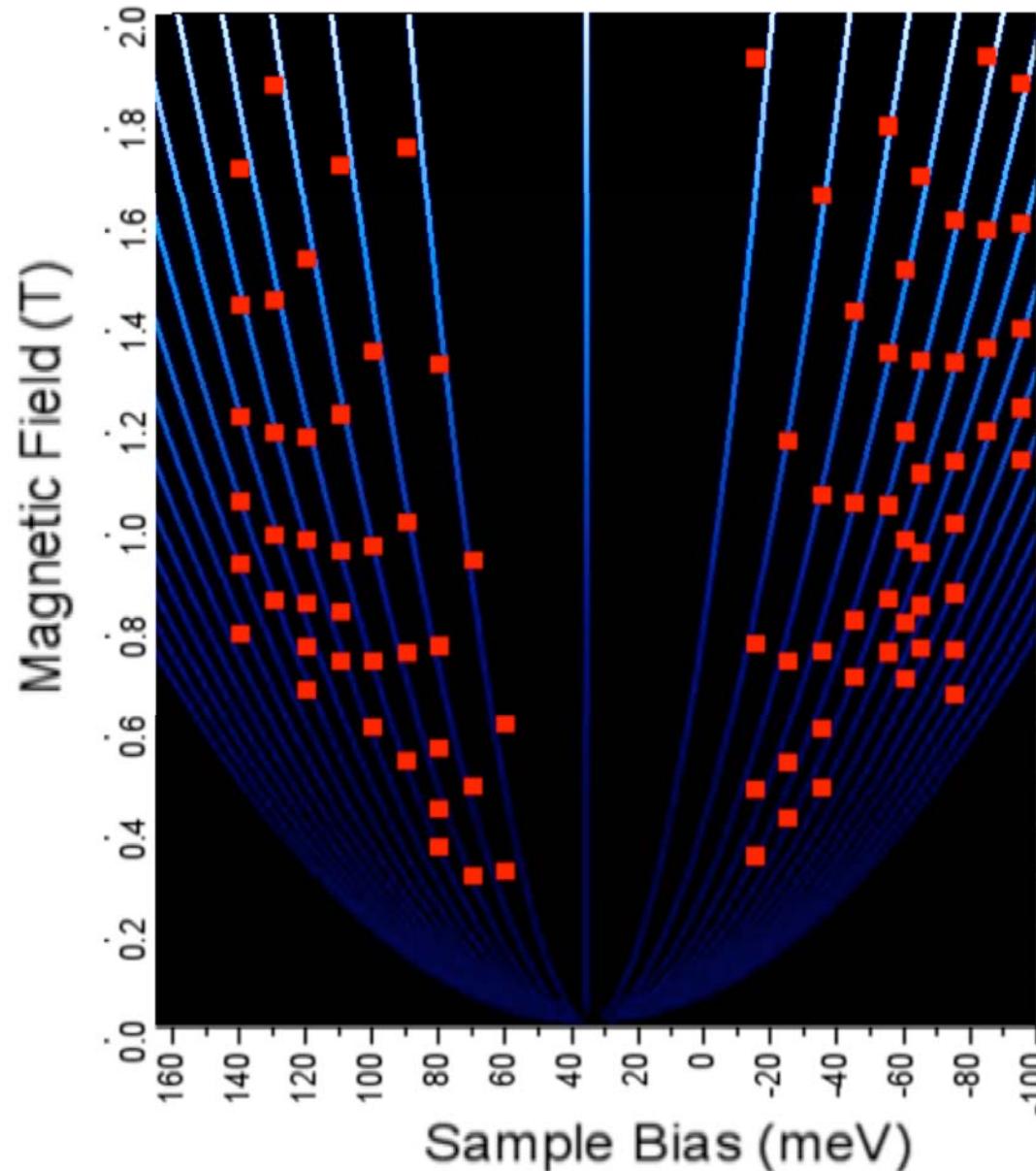
# Tunneling Magnetoconductance Oscillations

Analogous to SdH oscillations

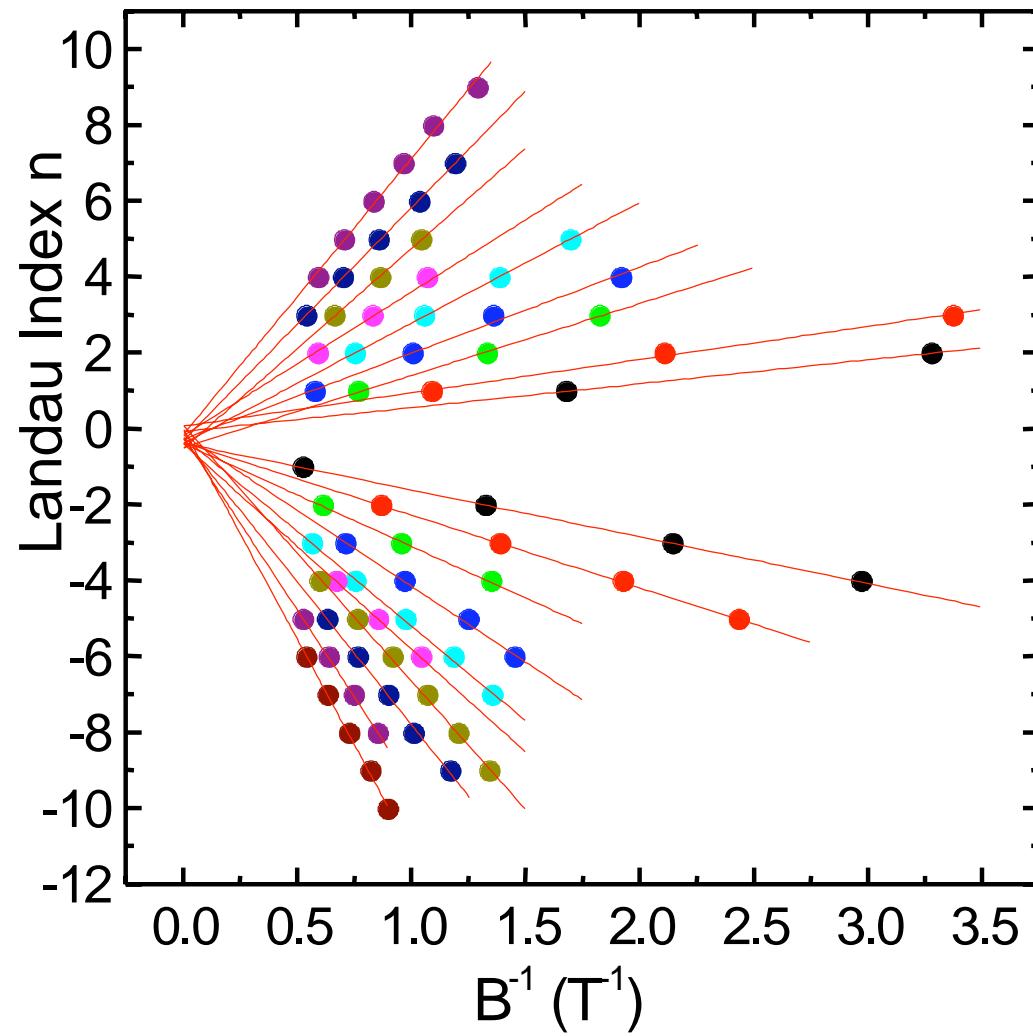


# $E$ vs $B$

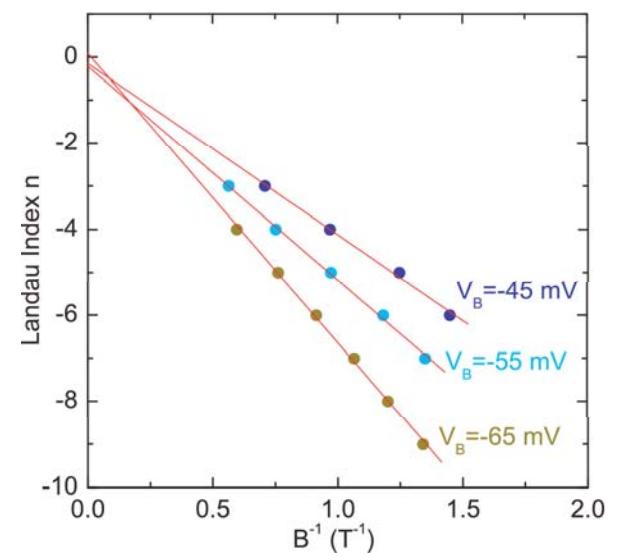
Fit with  $v = 1.07 \times 10^6$ ,



# Fan Plots

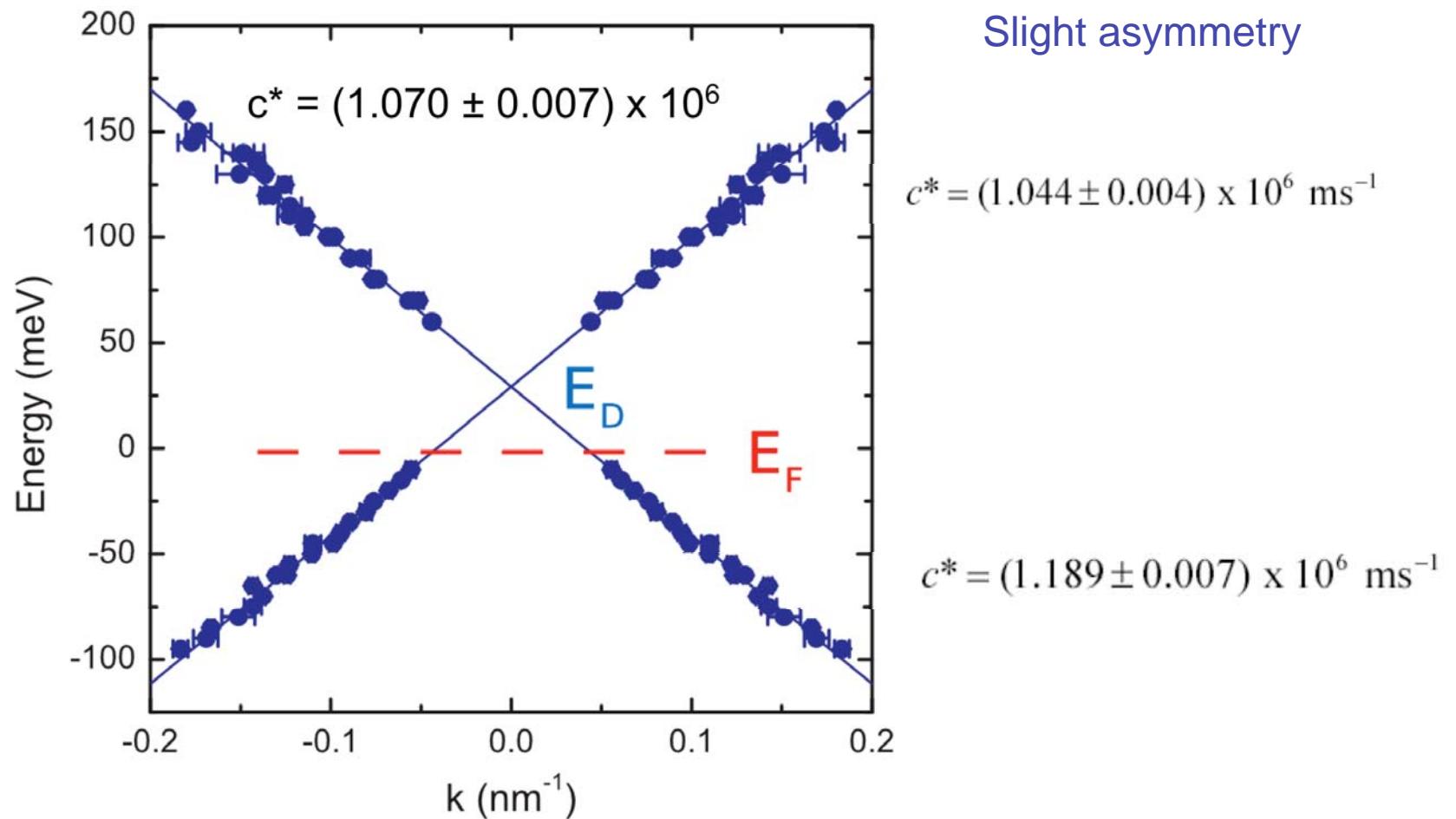


LL index vs 1/B for different energies



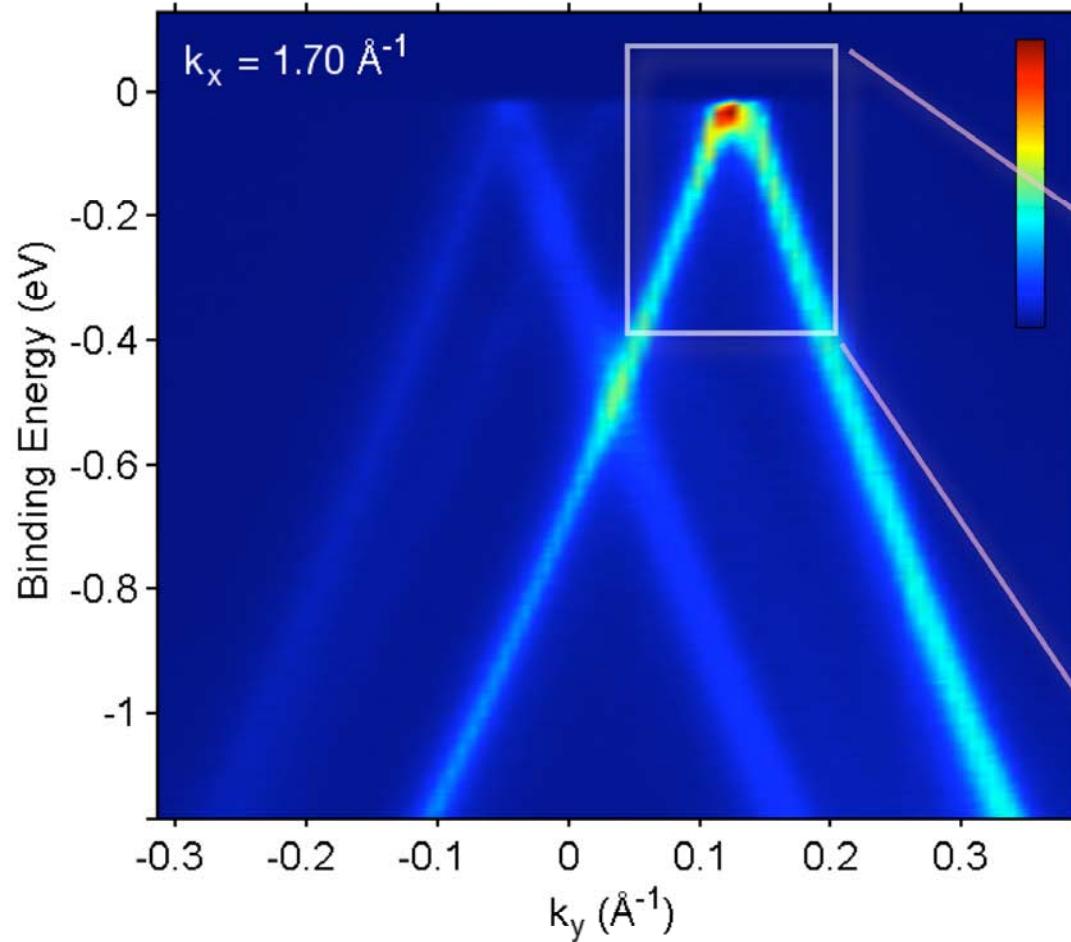
$$E_n = \text{sgn}(n) \sqrt{2e\hbar\tilde{c}^2 |n| B} \quad n=0, \pm 1 \dots$$

# Dispersion $E(k)$



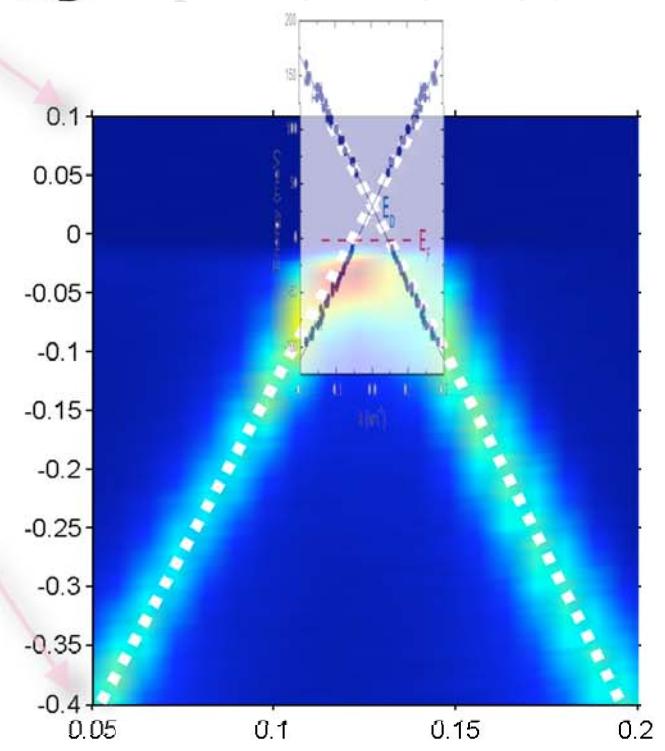
$$E_n = \text{sgn}(n) \sqrt{2e\hbar\tilde{c}^2 |n| B} \quad n=0, \pm 1, \dots = \hbar\tilde{c}k$$

# ARPES: C-face MEG



$$v_F = 0.87 \pm .02 \times 10^6 \text{ m/s}$$

$$E_D - E_F \sim 20 \pm 10 \text{ meV}$$



# Landau level spectroscopy

# Magneto spectroscopy and Raman scattering of C-face multi layer epitaxial graphene

C. Faugeras, M. Orlita, P. Plochocka, P. Neugebauer, M. Amado  
Montero, P. Kossacki, A.L. Barra, M.L. Sadowski, D.K. Maude,  
G. Martinez, M. Potemski

LNCMI-CNRS, Grenoble



LNCMI



C. Berger, W.A. de Heer

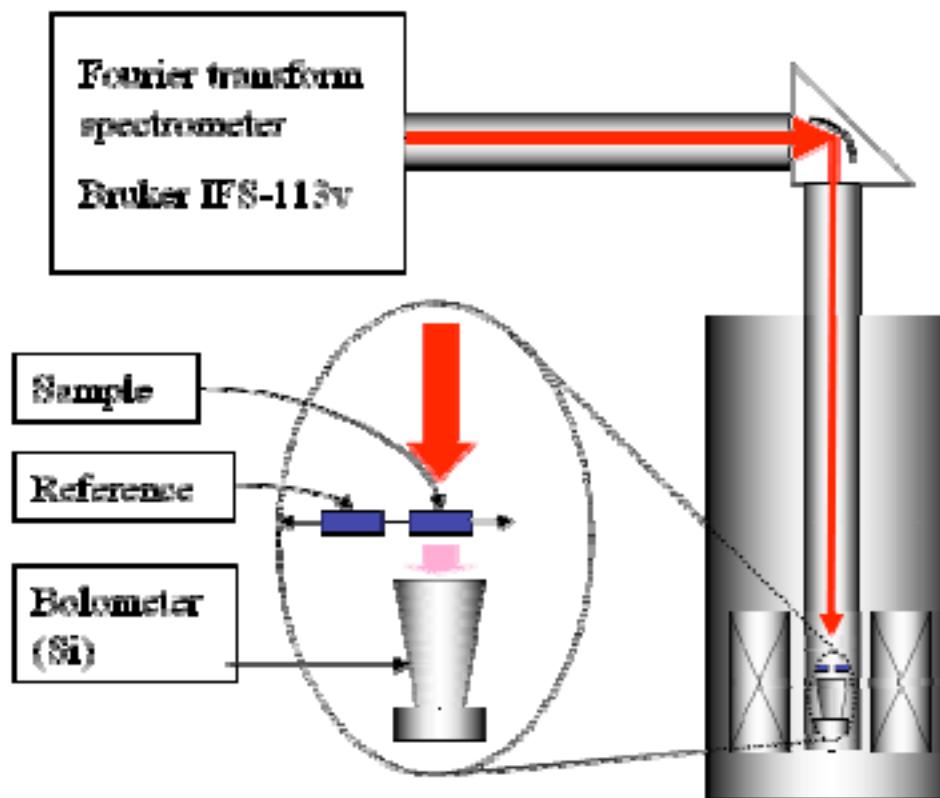
Georgia Tech, Atlanta



*Courtesy C. Faugeras*

# FIR and MIR Experimental setup

Far and middle infrared transmission (FIR and MIR)  
spectroscopy in magnetic fields  
= Landau level spectroscopy



Relative change of the sample transmission at finite magnetic field:

$$\frac{T(B)}{T(B=0)}$$

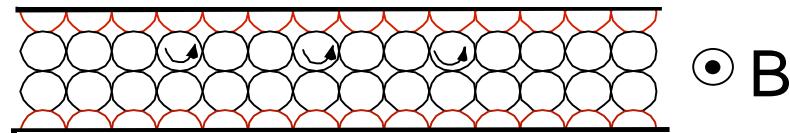
Magnetic field up to

$$B = 34 \text{ T}$$

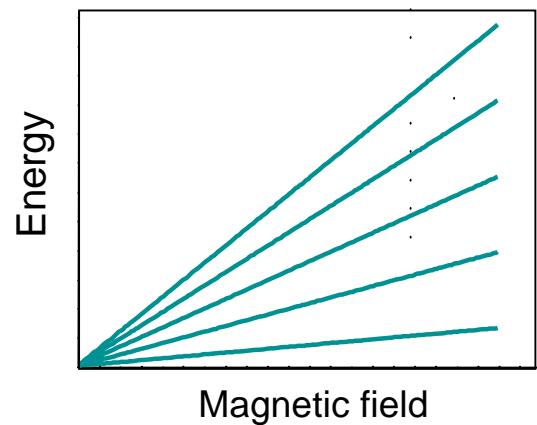
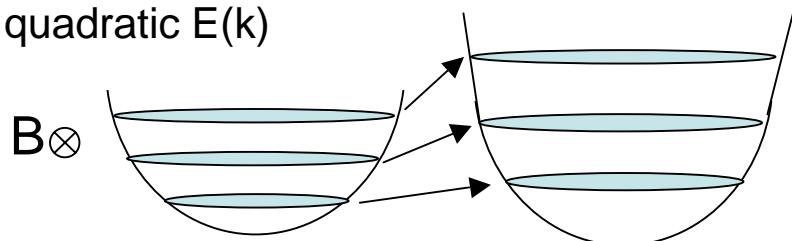
Possibility to perform absolute  
transmission measurement

# Bands in a magnetic field : Landau level

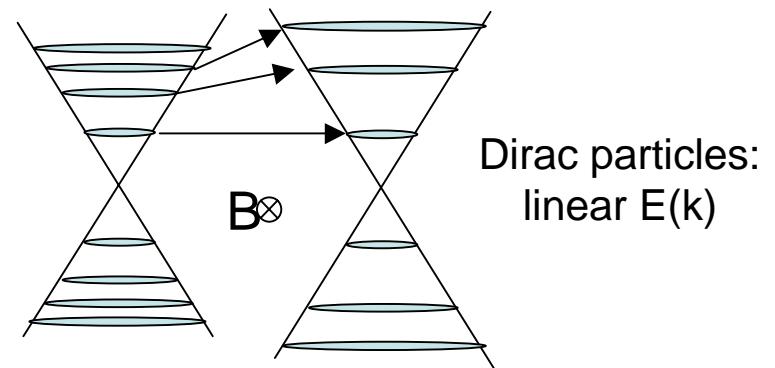
Energy quantization  $2\pi r_c = n\lambda_F$   
 $r_c = p/eB \quad \lambda_F = 2\pi / k_F$



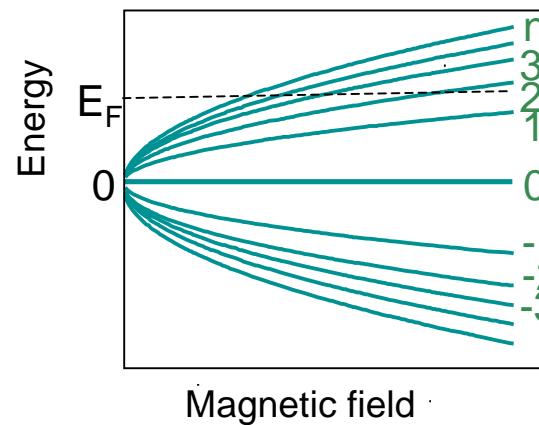
Normal electrons:  
quadratic  $E(k)$



$$E_n = \left(n + \frac{1}{2}\right) \frac{\hbar e B}{m^*}$$

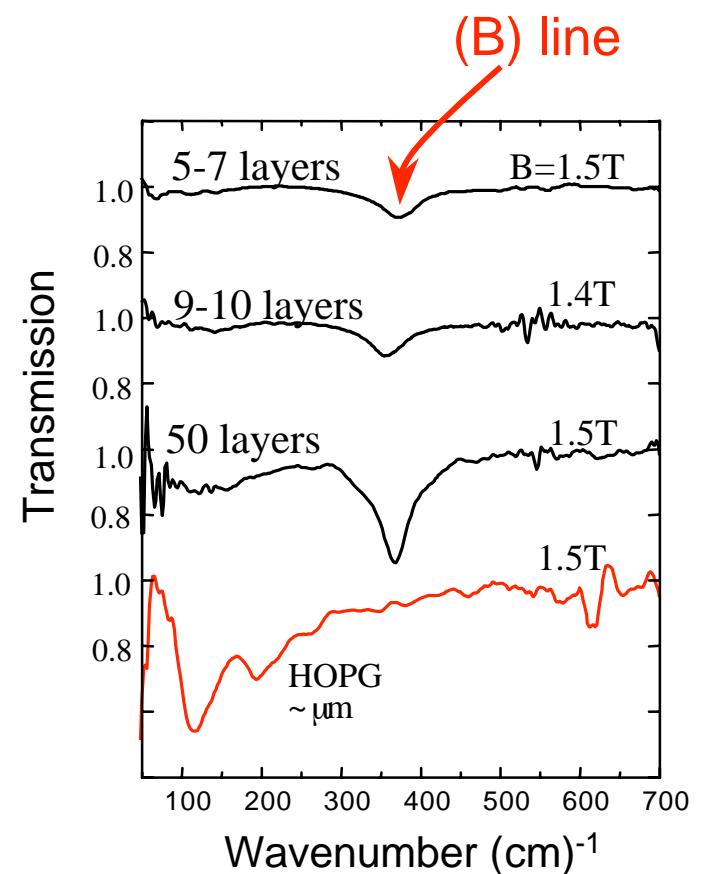
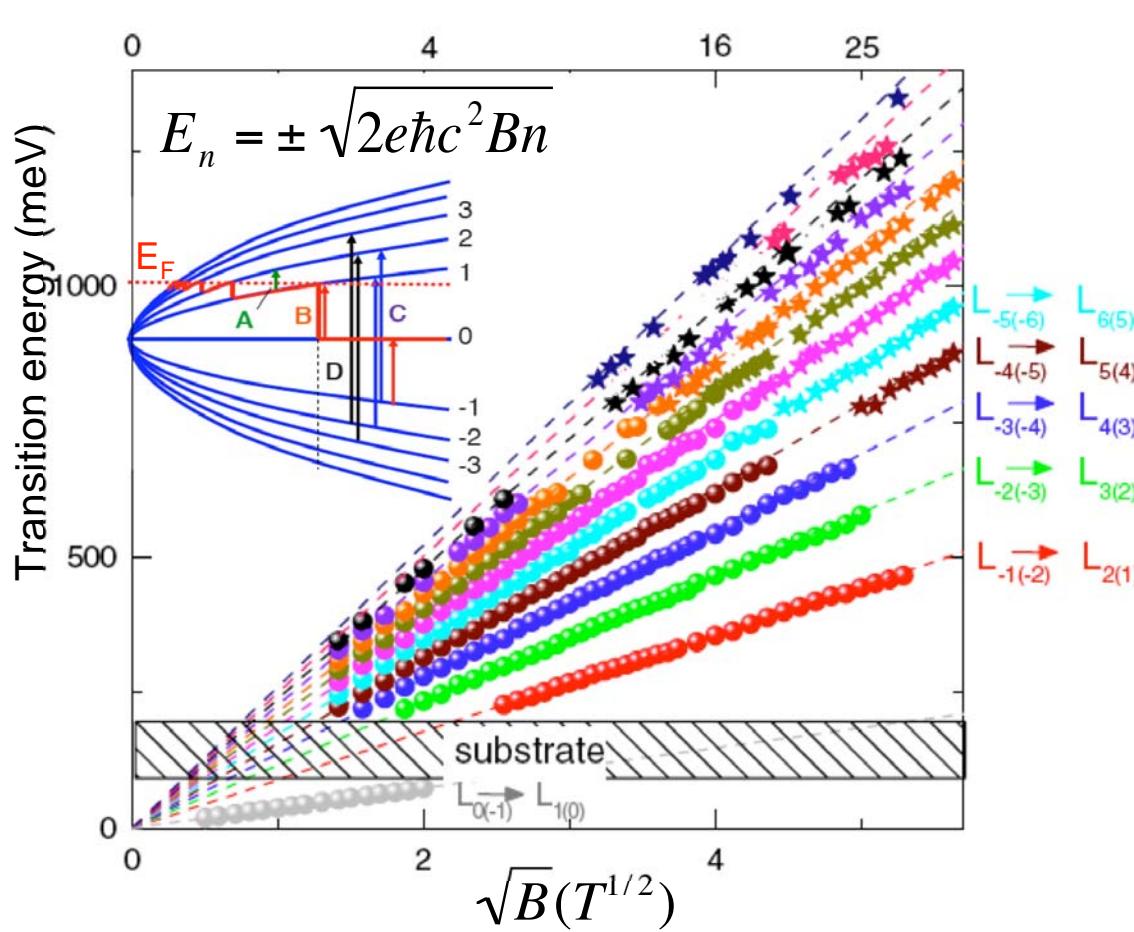


Dirac particles:  
linear  $E(k)$



$$E_n = \pm \sqrt{2e\hbar c^2 B n}$$

# Landau Spectra of C-face Graphene

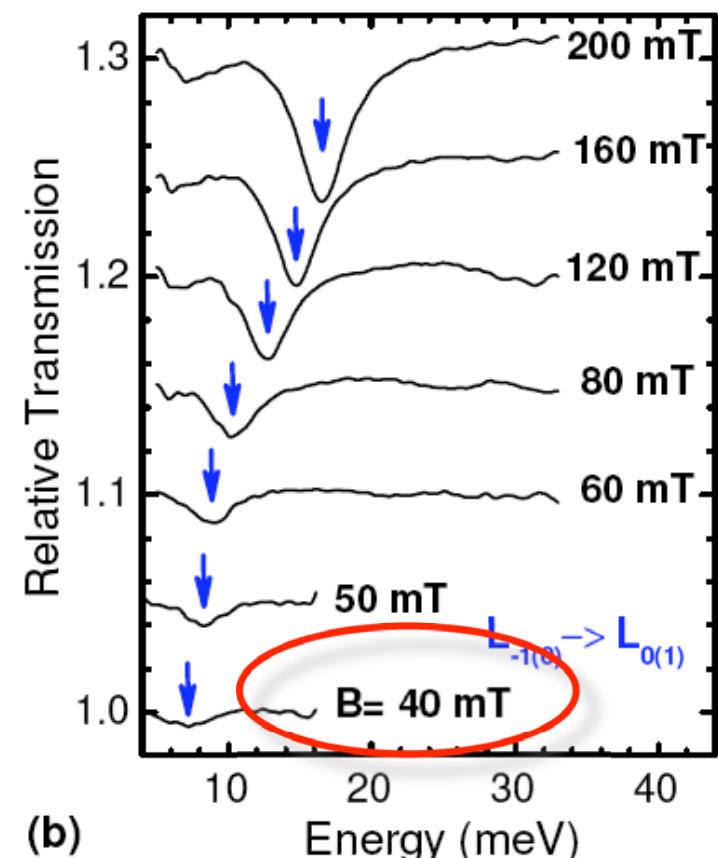
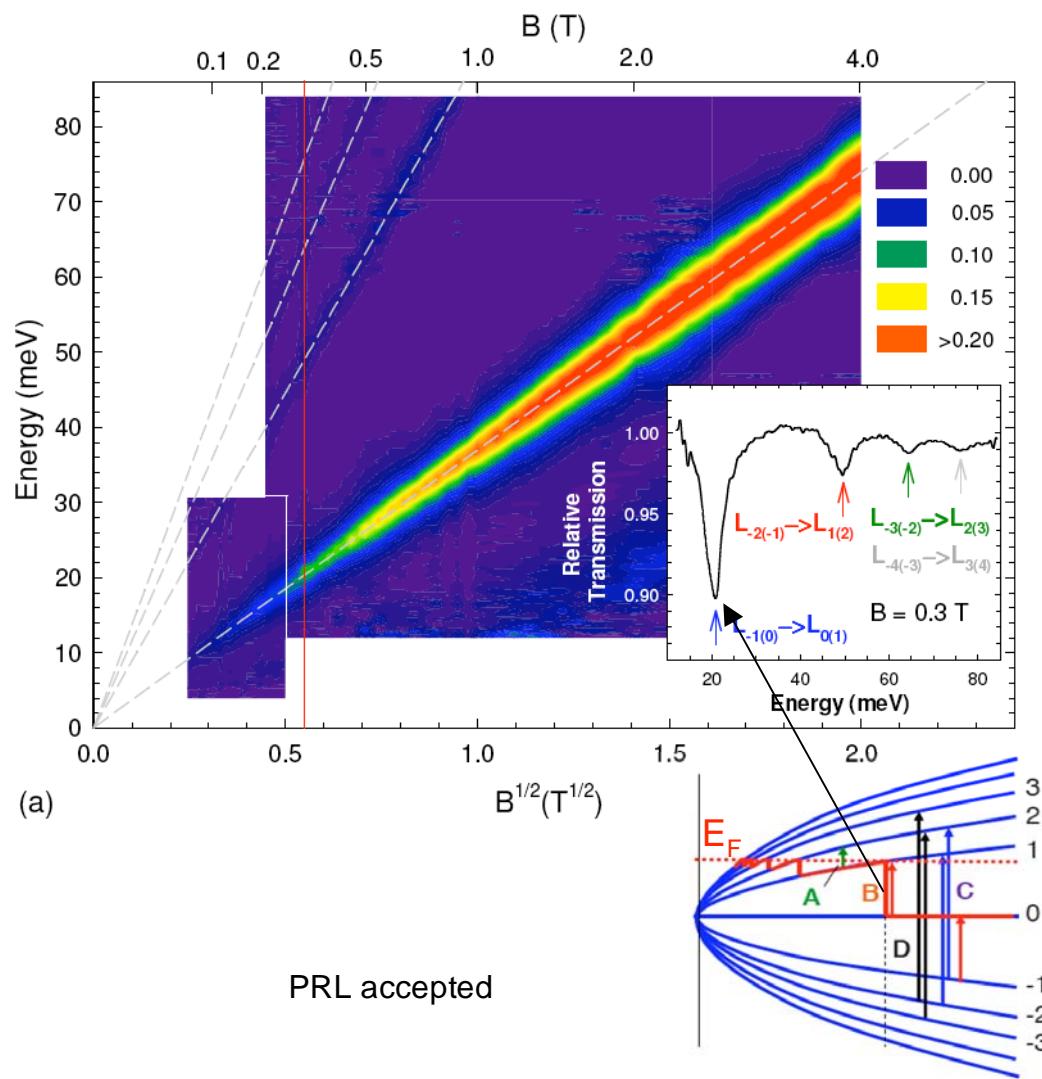


M. Potemski, G.Martinez, CNRS-LCMI

# IR cyclotron resonance spectroscopy

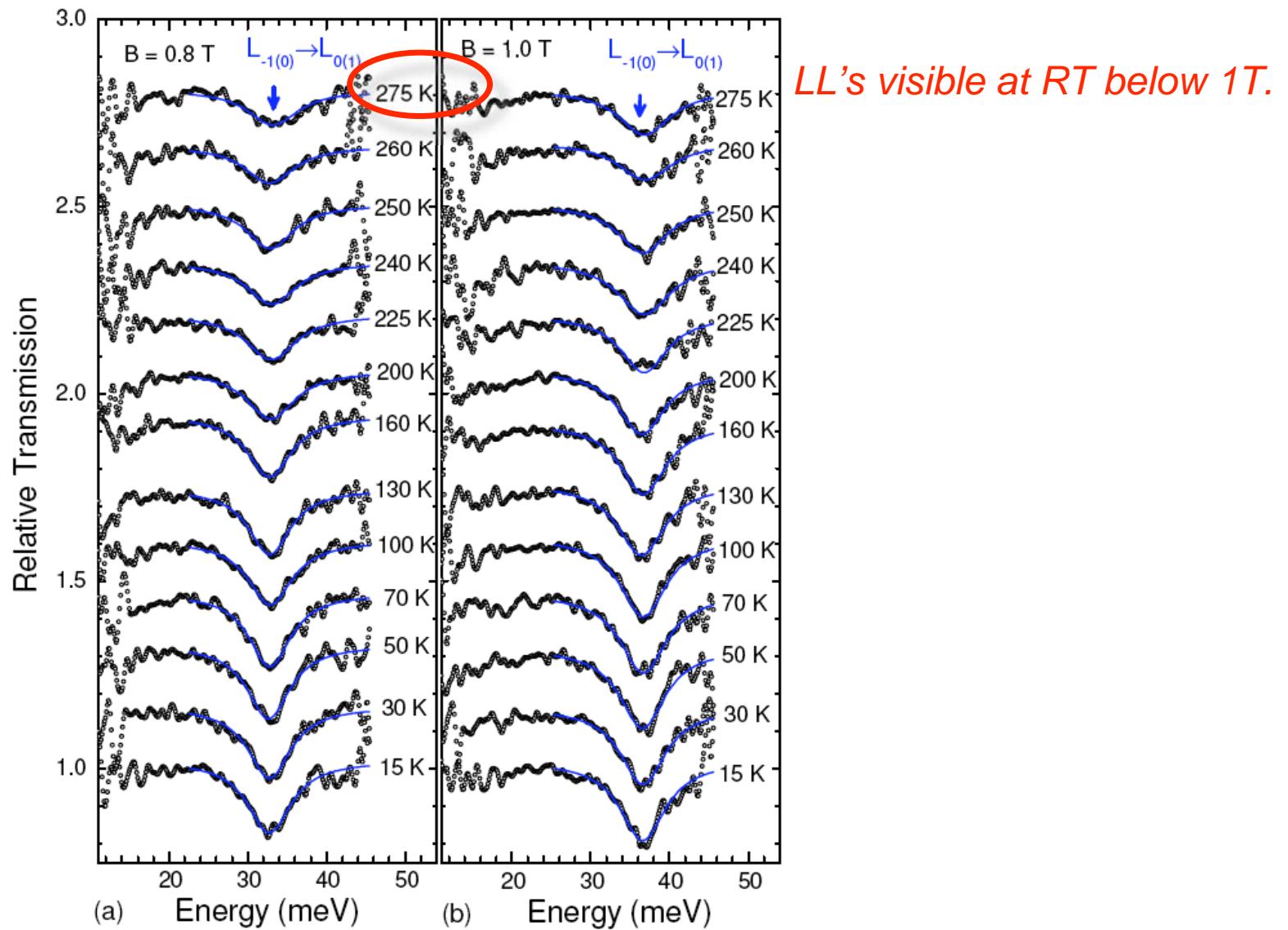
Approaching the Dirac point in high mobility multilayer epitaxial graphene

M. Orlita,<sup>1,2,3,\*</sup> C. Faugeras,<sup>1</sup> P. Plochocka,<sup>1</sup> P. Neugebauer,<sup>1</sup> G. Martinez,<sup>1</sup> D. K. Maude,<sup>1</sup> A.-L. Barra,<sup>1</sup> M. Sprinkle,<sup>4</sup> C. Berger,<sup>4,5</sup> W. A. de Heer,<sup>4</sup> and M. Potemski<sup>1</sup>



$\mu > 250,000$

# *IR cyclotron resonance spectroscopy*



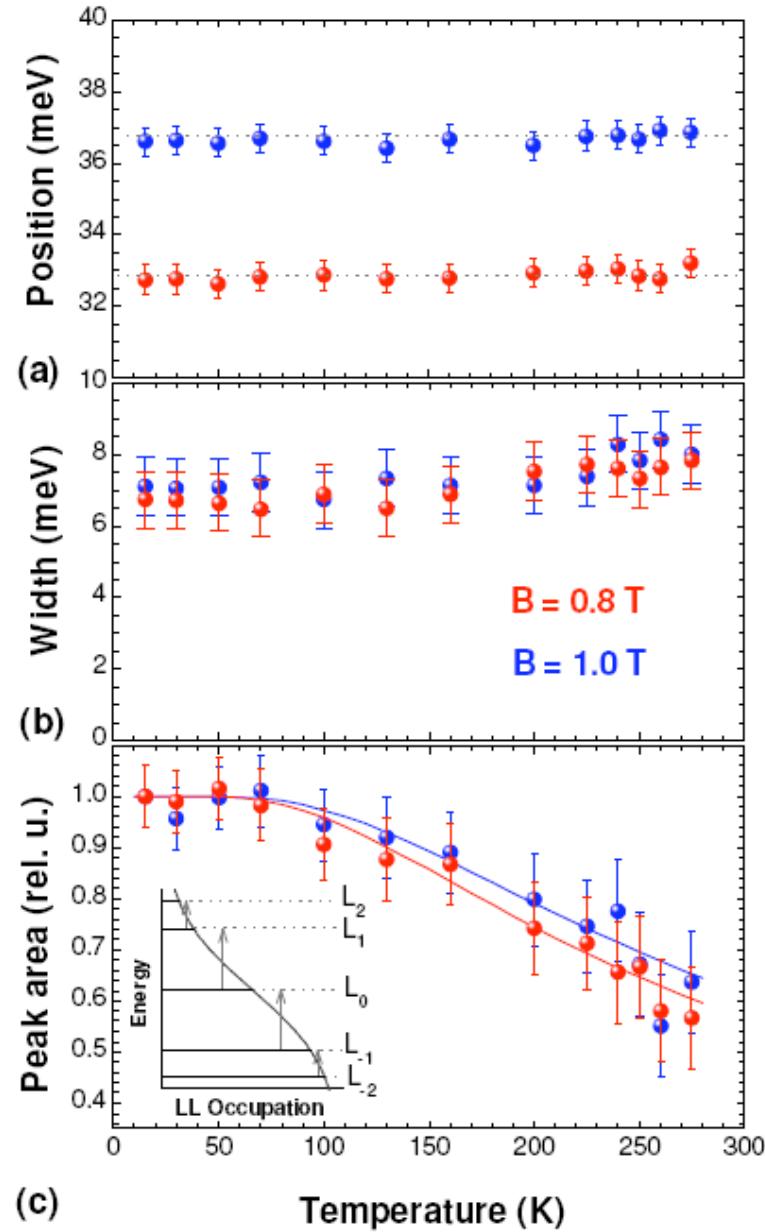
# MEG Landau Levels

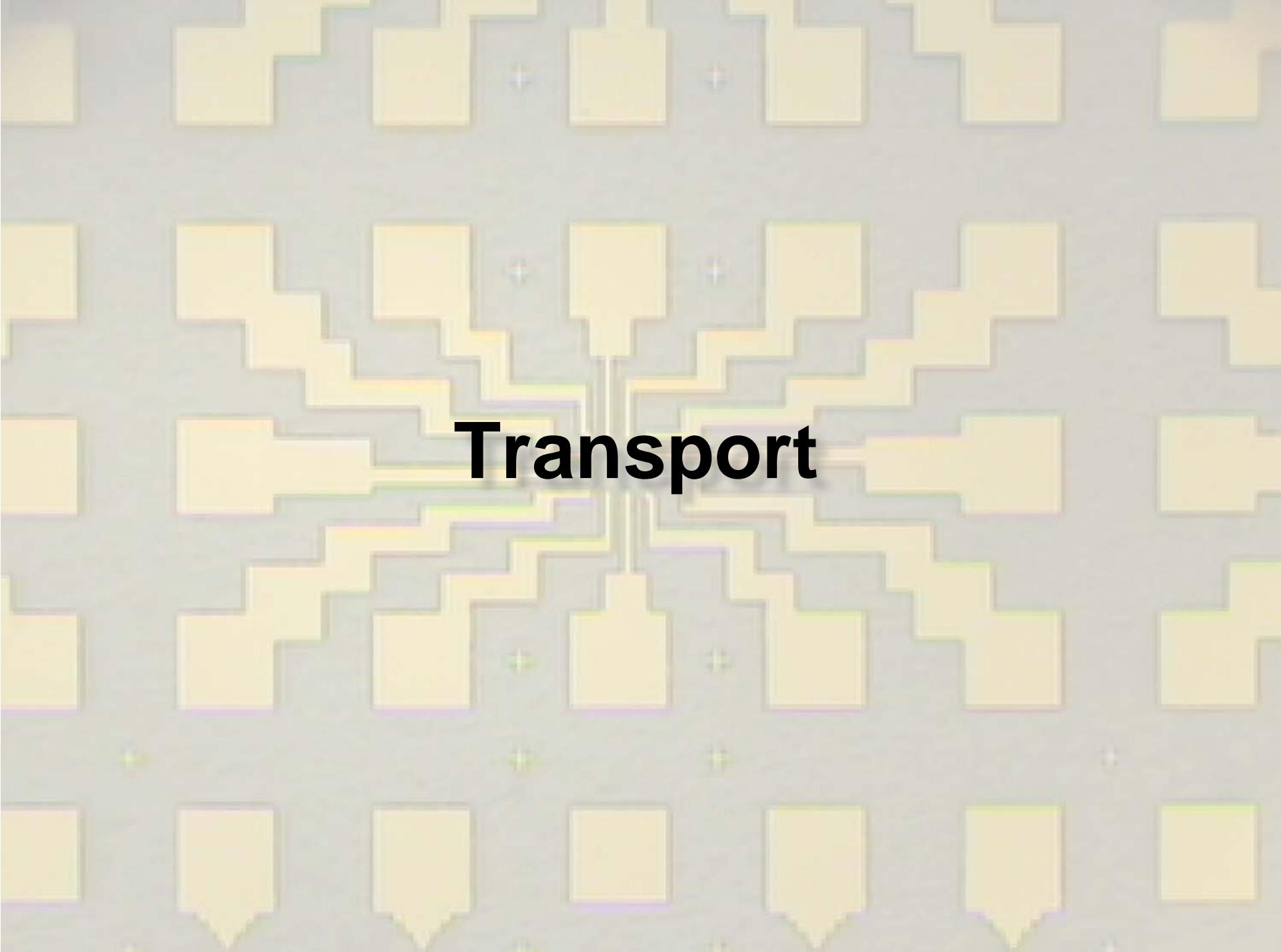
Temperature Independent LL's.

Temperature Independent widths

Boltzmann population of levels

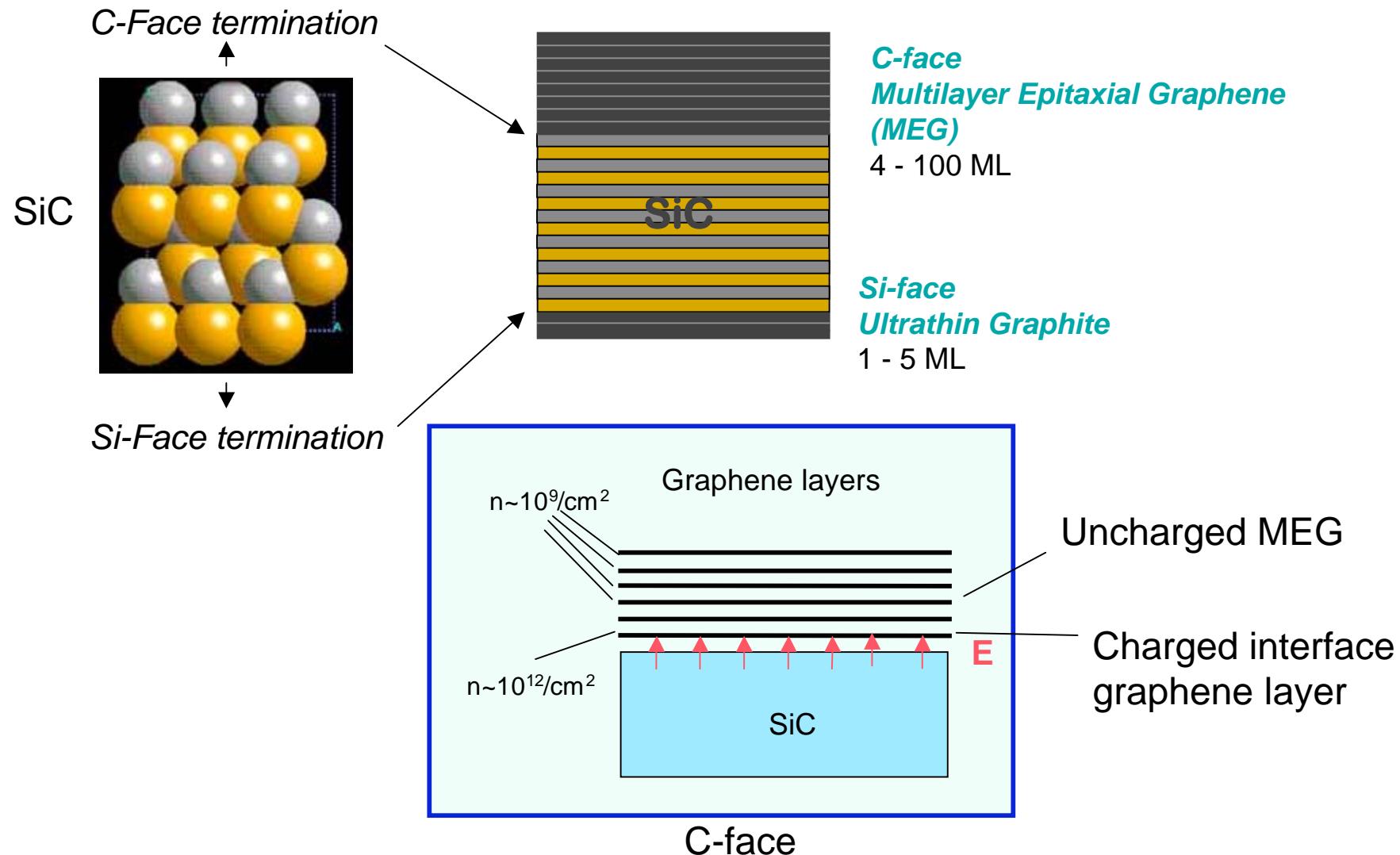
Weak Electron-Phonon Coupling:  
 $\mu > 250,000$  at RT



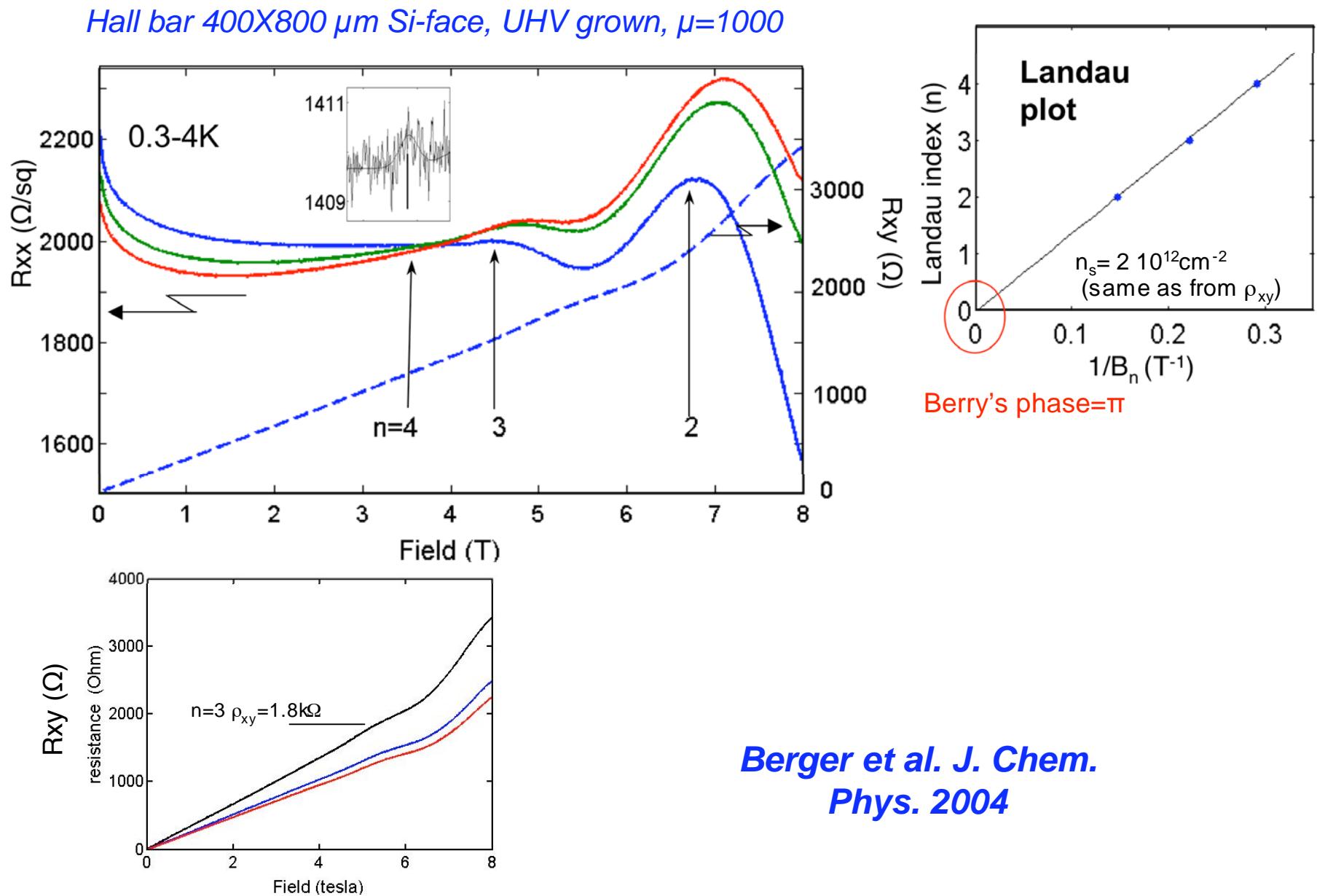


**Transport**

# *Epitaxial Graphene on 4H-SiC*



# Magneto-transport of 1-2 graphene layers on Si-face

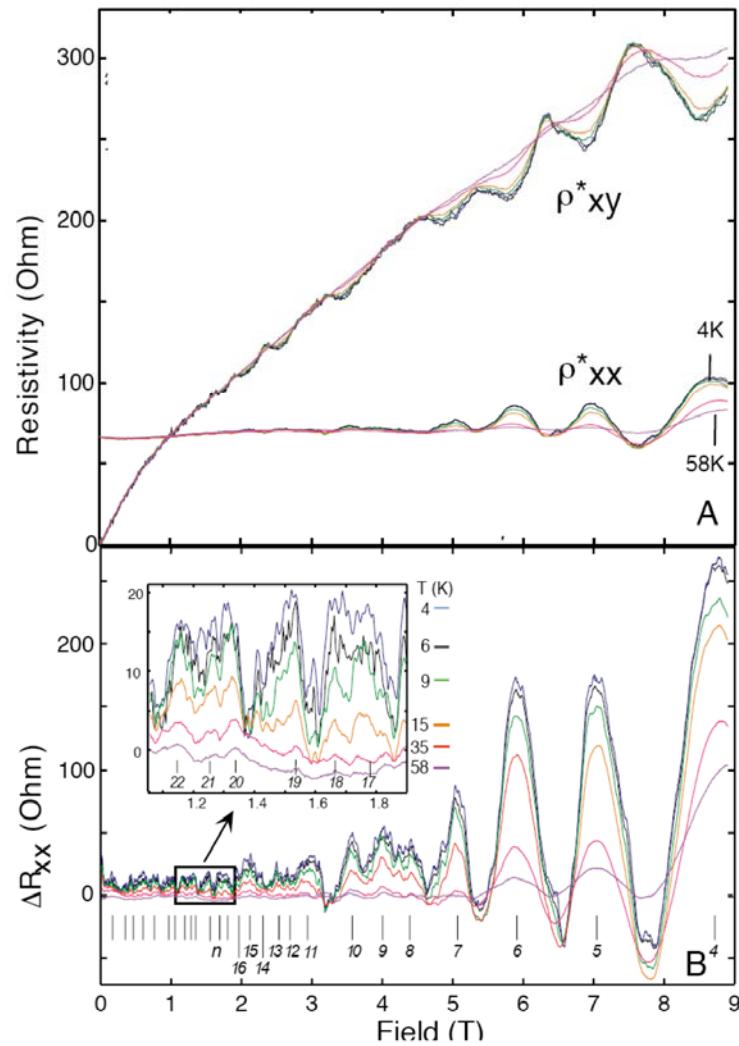


# Electronic Confinement and Coherence in Patterned Epitaxial Graphene

SCIENCE VOL 312 26 MAY 2006

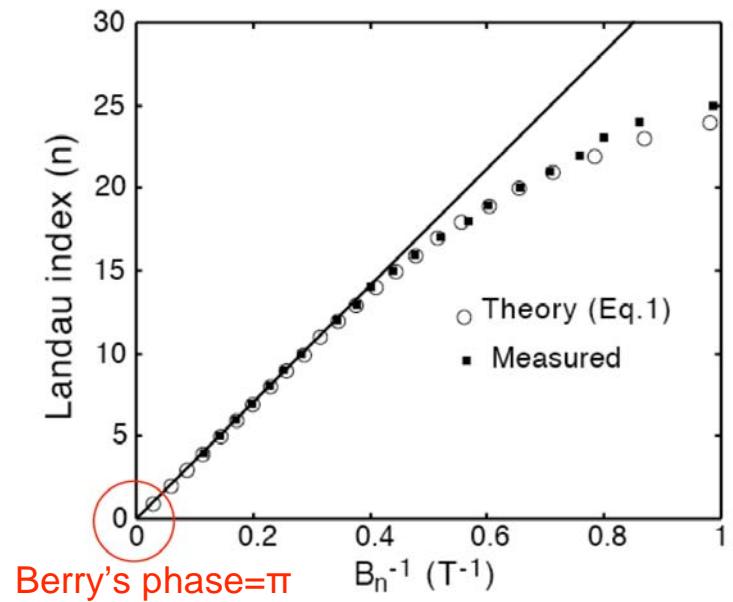
Claire Berger,<sup>1,2</sup> Zhimin Song,<sup>1</sup> Xuebin Li,<sup>1</sup> Xiaosong Wu,<sup>1</sup> Nate Brown,<sup>1</sup> Cécile Naud,<sup>2</sup> Didier Mayou,<sup>2</sup> Tianbo Li,<sup>1</sup> Joanna Hass,<sup>1</sup> Alexei N. Marchenkov,<sup>1</sup> Edward H. Conrad,<sup>1</sup> Phillip N. First,<sup>1</sup> Walt A. de Heer\*

T=4, 6, 9, 15, 35 and 58 K; -9 T≤B≤9 T.

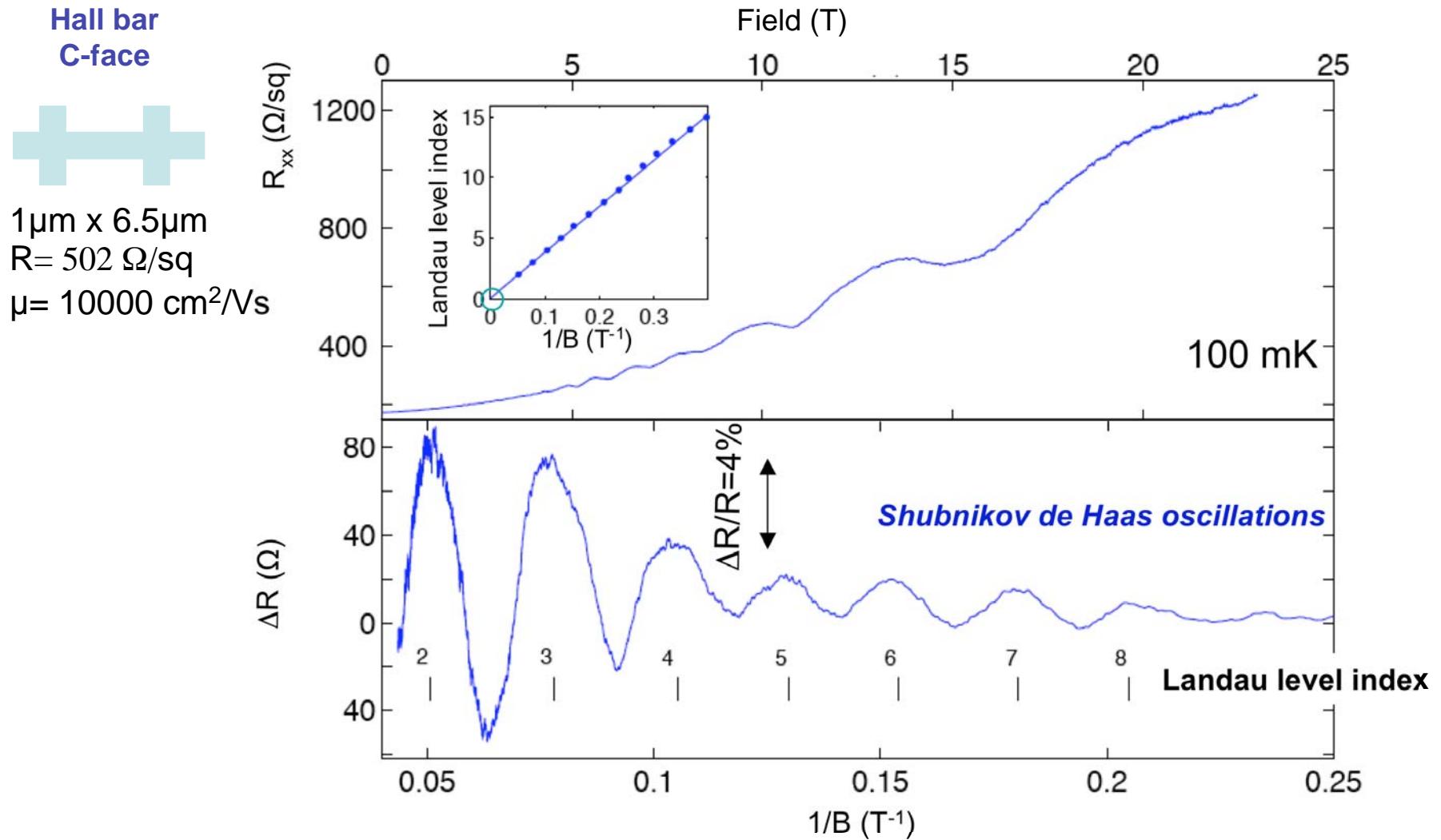


*C-face*  
*Hall bar*  
1μm×200 nm  
 $\mu^*=27000\text{cm}^2/\text{Vs.}$

Landau levels:  
 $E_n(B)=\sqrt{(2neBv_0)^2}$   
 Confinement:  
 $E_n(W)=n\pi v_0/W$   
 Confined Landau levels:  
 $E_n(B,W)\approx [E_n(W)^4+E_n(B)^4]^{1/4}$

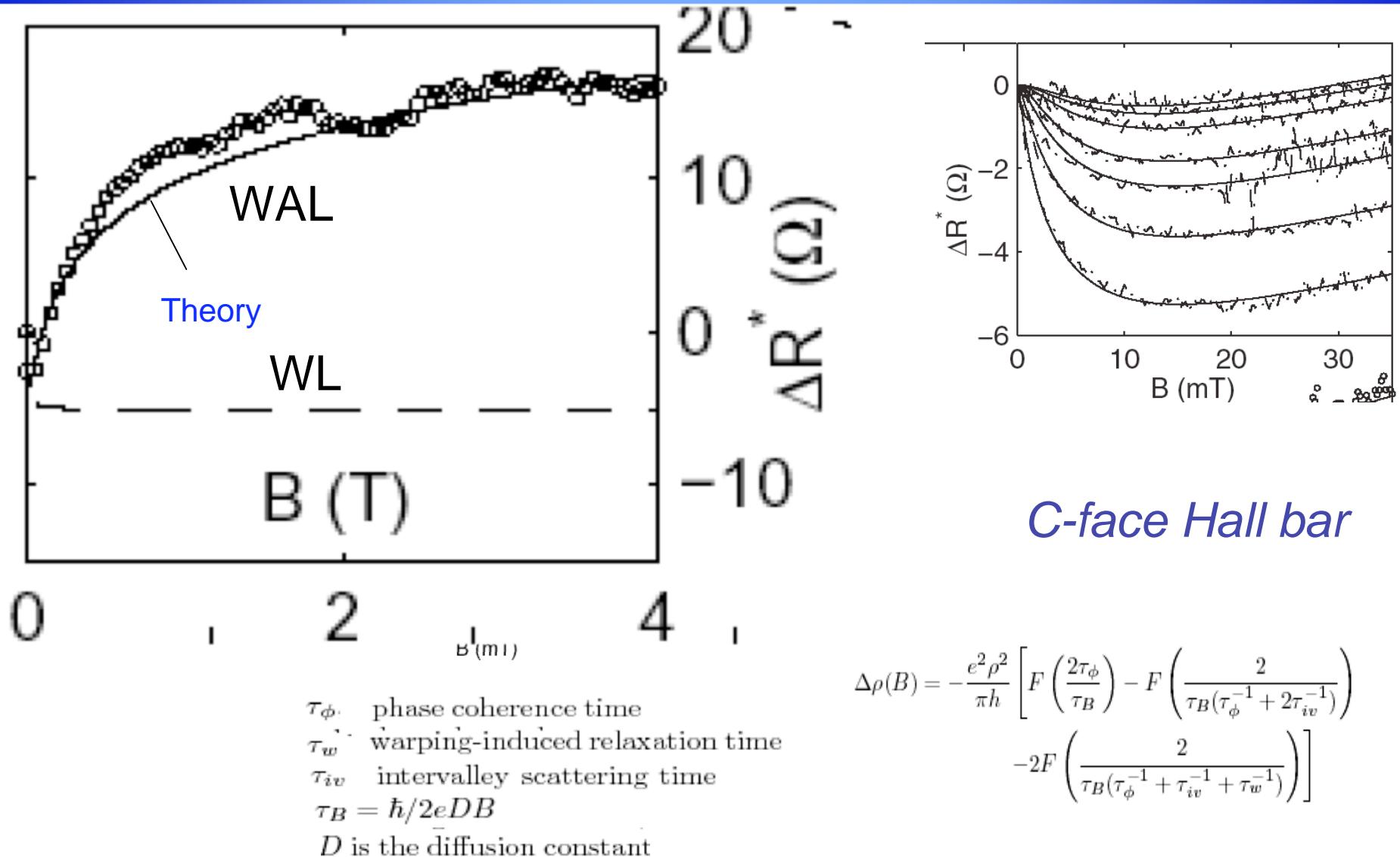


# Magnetotransport: graphene like; Berry's phase = $\pi$ (No QHE)



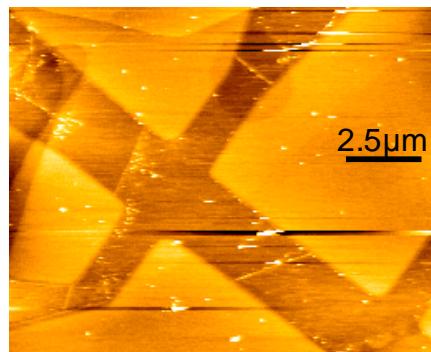
Solid State Com. 2007, Grenoble/GIT collaboration

## Weak Antilocalization in Epitaxial Graphene: Evidence for Chiral Electrons

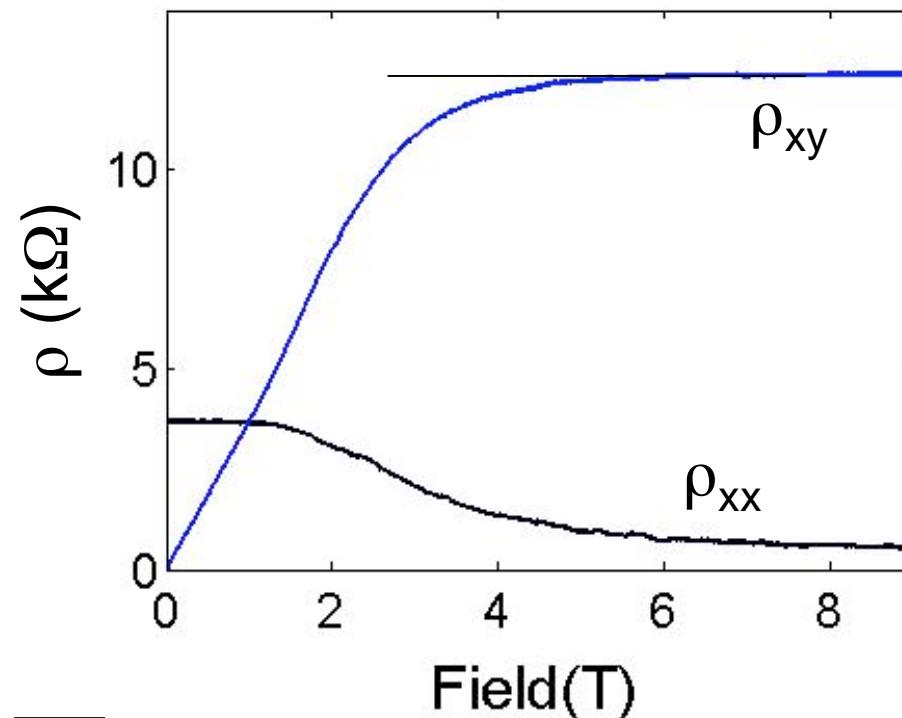
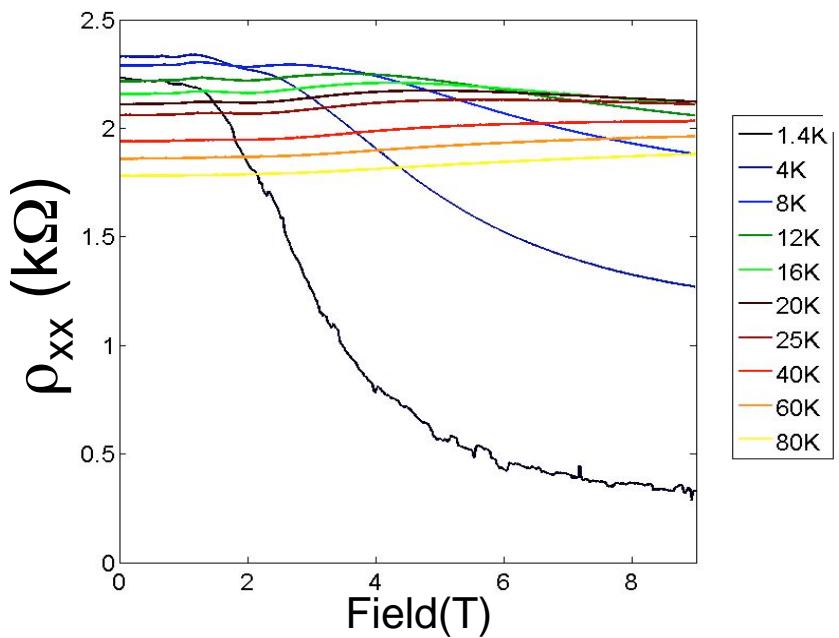
Xiaosong Wu,<sup>1</sup> Xuebin Li,<sup>1</sup> Zhimin Song,<sup>1</sup> Claire Berger,<sup>1,2</sup> and Walt A. de Heer<sup>1</sup>

# Magnetotransport of ~1 graphene sheet on C-face

Cross etched in a flat terrace

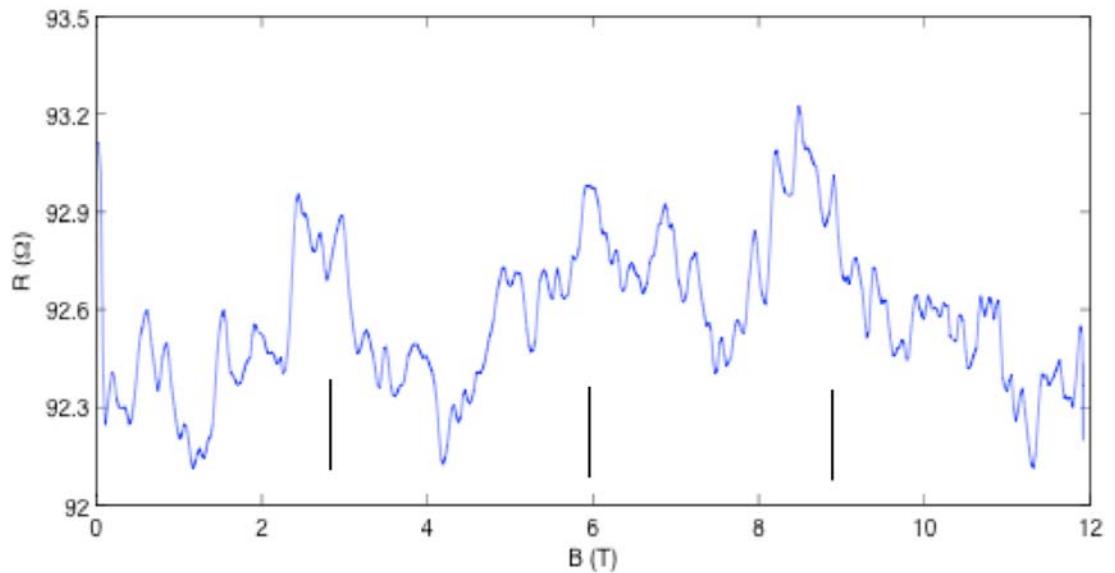
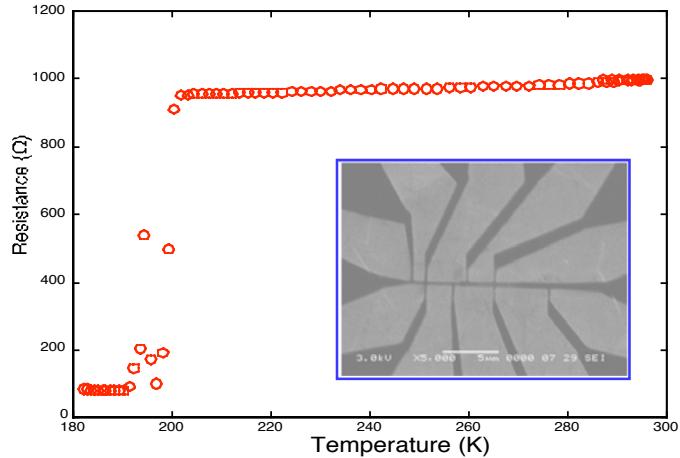


$$\mu \sim 9000 \text{ cm}^2/\text{Vs}$$
$$n_s = 1.6 \times 10^{11} \text{ cm}^{-2}$$

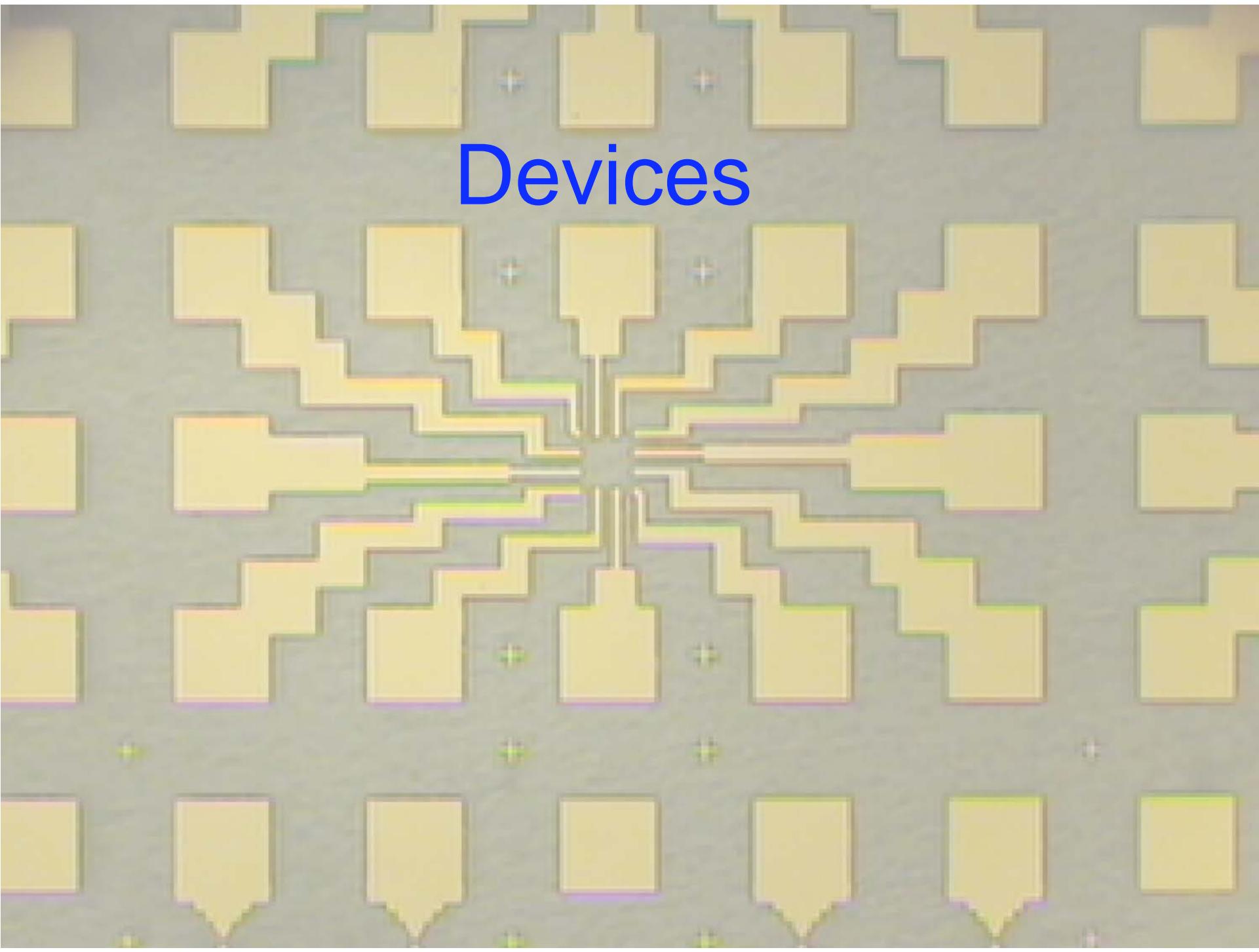


## Anomalous Conductance Transition

- A reversible, reproducible, drop in the conductivity is observed at 200K.
- The resistance is at its theoretical minimum .
- Transport is phase coherent over the entire structure (0.5X5  $\mu$ m).
- Resistance is at its theoretical minumum (no boundary scattering!)
- Oscillations periodic in the magnetic field are seen.

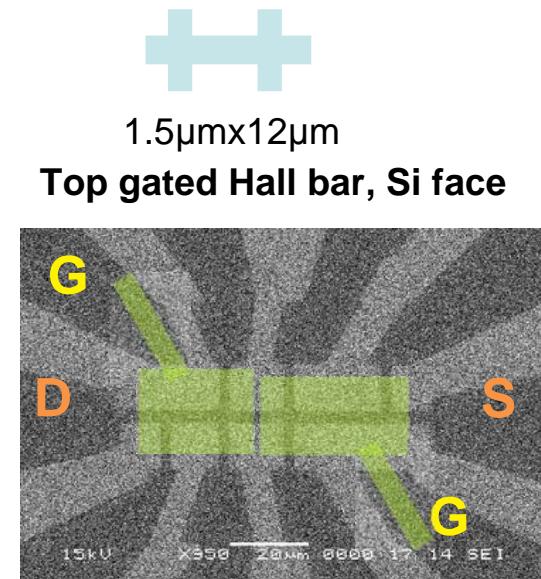
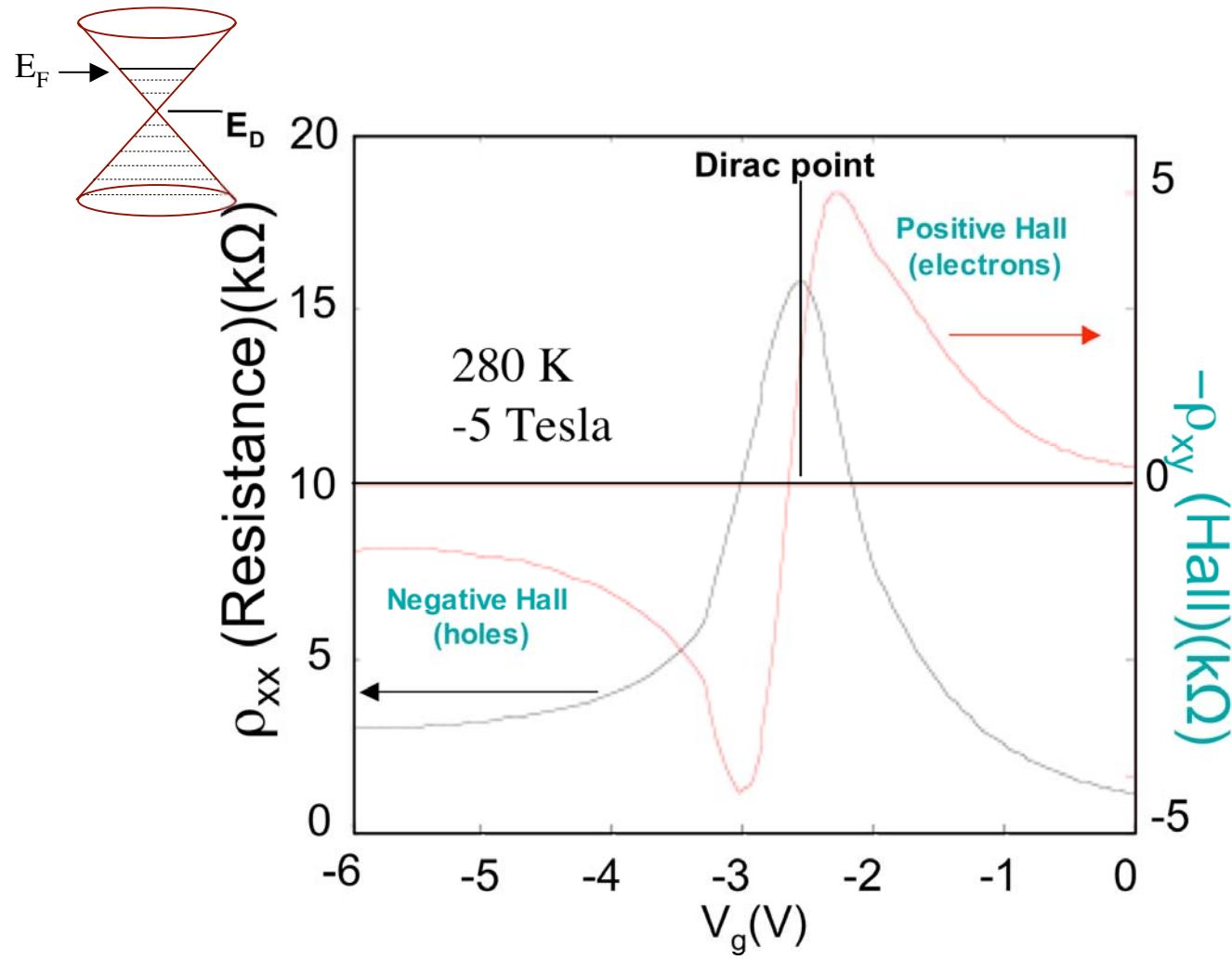


Could this be the Hoffstadter butterfly?  
(Moire with a 20 nm lattice constant)

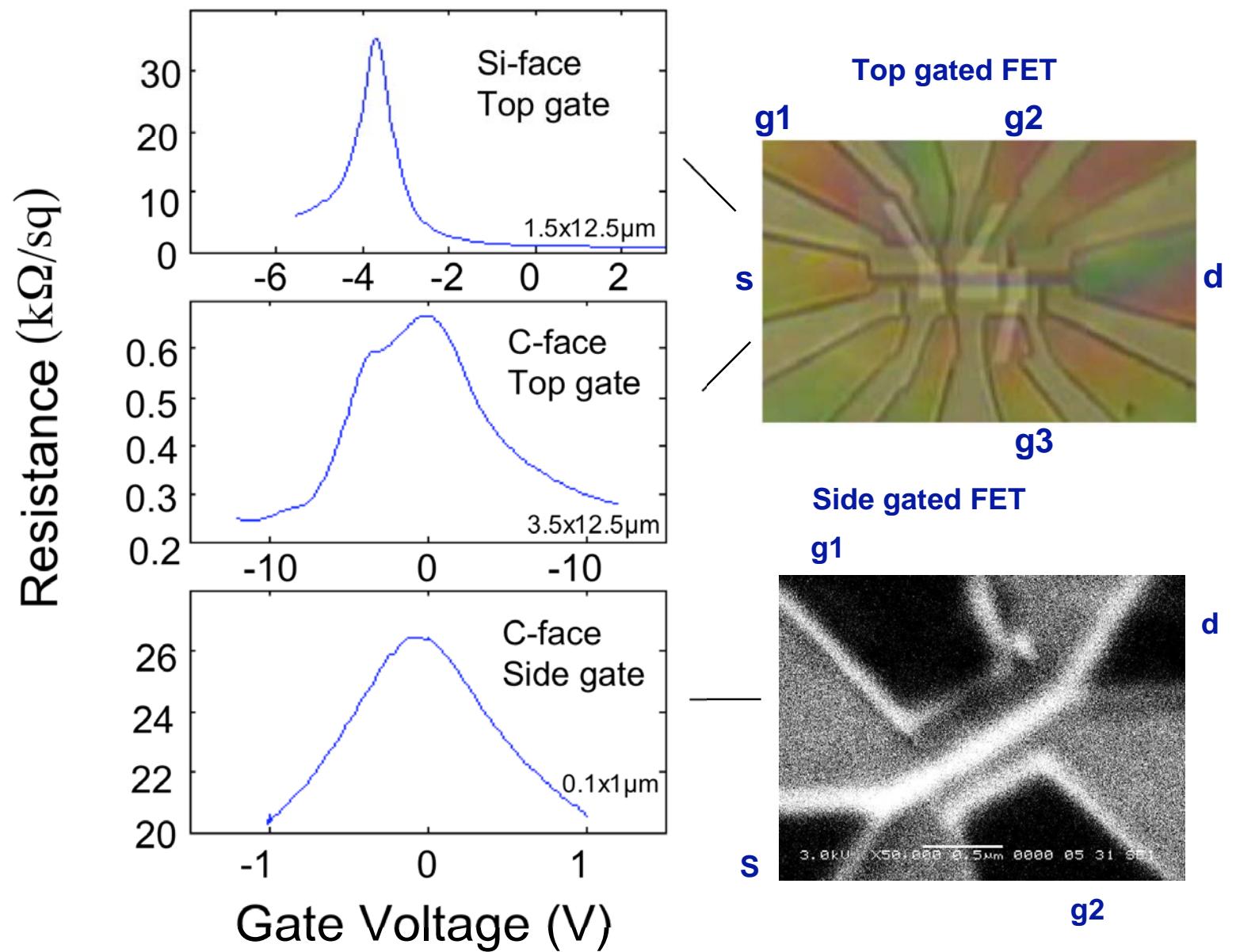


Devices

# The Dirac point



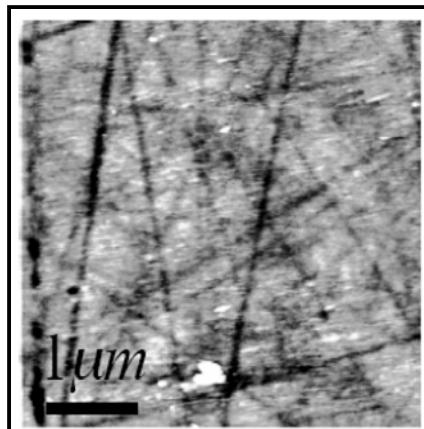
# *Top and side gated FETs*



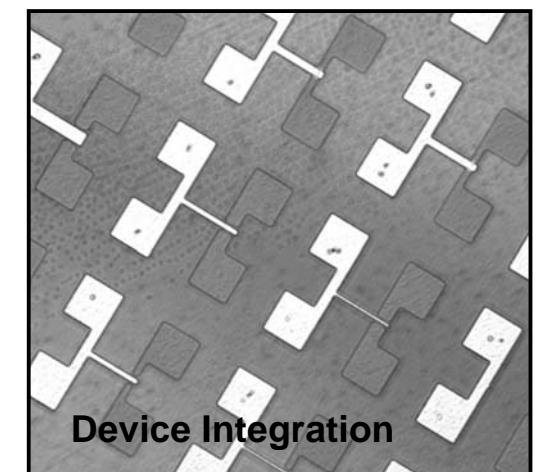
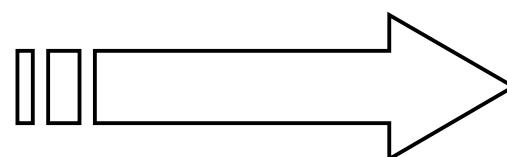
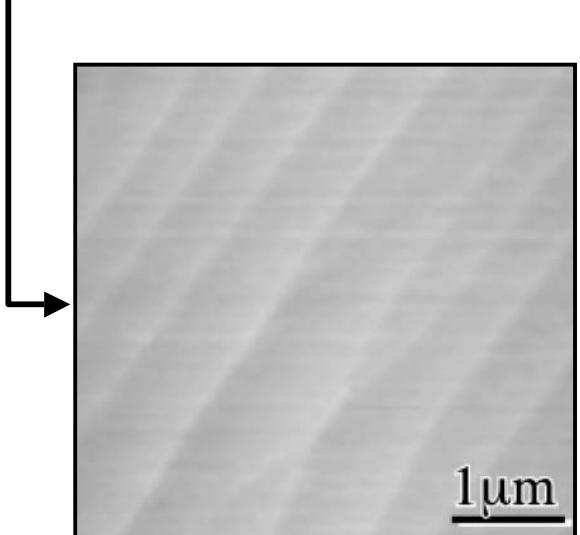
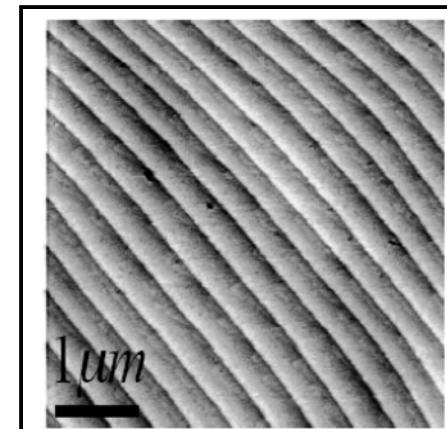
*The first epitaxial graphene transistors*

# *Production process*

**SiC blank**

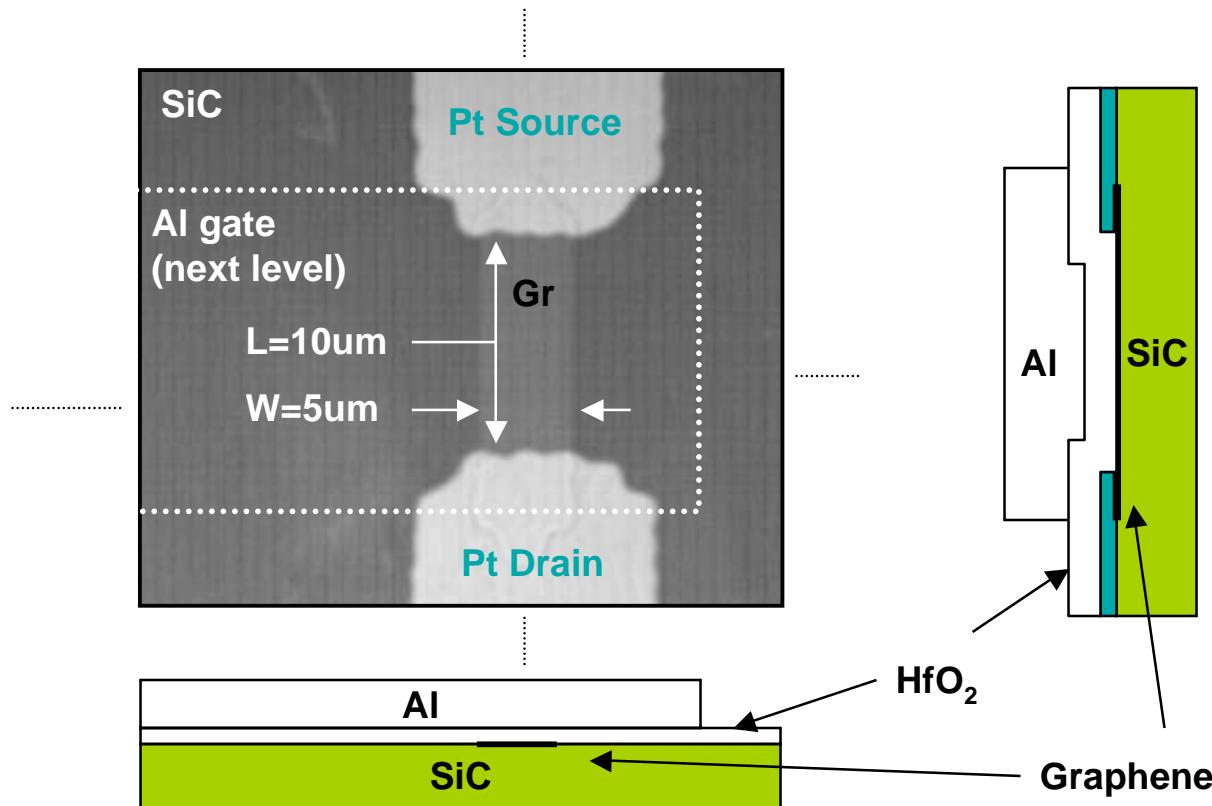


**Hydrogen etch**



*Pattern*

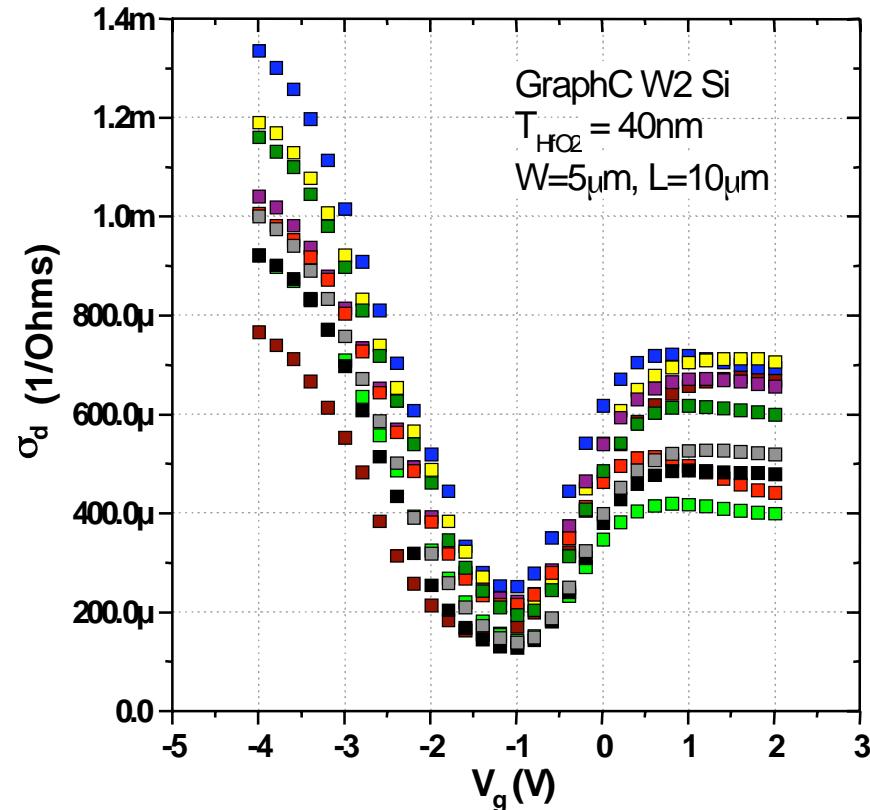
# Final Device Geometry



- Device description and cross section
  - Nominal device – Graphene/SiC active layer (C-side), L = 10um, W = 5 um, ridge parallel, 50nm HfO<sub>2</sub> dielectric, Al gate
  - Microscope image shown before gate lift-off

J. Kedzierski, P. L. Hsu, P. Healey, P. W. Wyatt, C. L. Keast, M. Sprinkle, C. Berger, W. A. de Heer, *Epitaxial graphene transistors on SiC substrates*, IEEE Trans Electron Dev **55**, 2078 (2008).

# Set of Identical Devices (Si-face)



- Minimum conductivity
  - $130\mu\text{S}$  to  $250\mu\text{S}$
- Field Effect Mobility values
  - $400$ - $1000 \text{ cm}^2/\text{Vs}$
- $I_{\text{on}}/I_{\text{off}} \sim 5$

Drain current vs. gate voltage at  
 $V_d = 0.5\text{V}$

J. Kedzierski, P. L. Hsu, P. Healey, P. W. Wyatt, C. L. Keast, M. Sprinkle, C. Berger, W. A. de Heer, *Epitaxial graphene transistors on SiC substrates*, Ieee T Electron Dev **55**, 2078 (2008).

# Lithography

98 ribbons per 3.5 x 4.5 mm chip

Hall bars and 2-point devices

